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# HAC TEST REPORT

Report No. 2017SAR232

FCC ID: QRP-AZUMIIROA55QL  
Applicant: AZUMI S.A  
Product: Mobile Phone  
Model: IRO A55 QL  
Issue Date: 2017-05-31

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## Standards

Applicable Standards	<b>ANSI C63.19-2011:</b> Methods of Measurement of Compatibility between Wireless Communication Devices and Hearing Aids
	<b>KDB 285076 D01v04r01:</b> HAC Guidance
	<b>KDB 285076 D02V02:</b> T-Coil testing for CMRS IP

## Conclusion

Hearing Aid Compatibility (HAC) of this equipment has been measured in all cases requested by the relevant standards above. The HAC measurement indicates that the EUT complies with the HAC limits of the ANSI C63.19-2011.

## Change History

Version	Change Contents	Author	Date
V1.0	First edition	Chen Qiang	2017-05-15
V2.0	Update few mistake words	Chen Qiang	2017-05-31

Note: The last version will be invalid automatically while the new version is issued.

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## 1. STATEMENT OF COMPLIANCE

The Rating of Hearing Aid Compatibility (HAC) found during testing for **AZUMI S.A Mobile Phone IRO A55 QL** are as follows.

### Rating of HAC summary:

Band	M-Rating	T-Rating
GSM850	M4	T3
GSM1900	M4	T3
WCDMA BAND II	M4	T4
WCDMA BAND V	M4	T4

This device is in compliance with HAC limits specified in guidelines FCC 47 CFR § 20.19 and ANSI Standard ANSI C63.19.

## 2. Administrative Information

### 2.1 Project Information

Date of start test            2017-05-11  
Date of end test:            2017-05-12

### 2.2 Test Laboratory Information

Company:                    Shanghai Tejet Communications Technology Co., Ltd Testing Center  
Address:                    Room 6205-6208, Building 6, No.399 Cailun Rd. Zhangjiang Hi-Tech  
                                  Park, Shanghai, China  
Post Code:                  210203  
Tel:                            +86-21-61650880  
Fax:                            +86-21-61650881  
Website:                    [www.tejet.cn](http://www.tejet.cn)

### 2.3 Test Environment

Temperature:                20°C~25°C  
Relative Humidity:        20%~70%

### 3. Client Information

#### 3.1 Applicant information

Company Name: AZUMI S.A  
Address: Avenida Aquilino de la Guardia con Calle 47, PH Ocean Plaza, Piso 16 of. 16-01, Marbella, Ciudad de Panamá City, Rep. Panamá

#### 3.2 Manufacturer Information

Company Name: AZUMI HK LTD  
Address: FLAT/RM 18 BLK 1 14/F GOLDEN INDUSTRIAL BUILDING 16-26 KWAI TAK STREET KWAI CHUNG, HK



## 4. Equipment Under Test (EUT) and Accessory Equipment (AE)

### 4.1 Information of EUT

Device type	Portable device	
Product name	Mobile Phone	
Exposure category	Uncontrolled environment / general population	
Device operation configuration:		
Operating Mode(s):	GSM850	
	GSM1900	
	WCDMA BAND II/V	
Test modulation	(GSM)GMSK, (WCDMA) QPSK	
Antenna type:	Internal antenna	
Operating frequency range(s):	Band	Tx(MHz)
	GSM850	824.2~848.8
	GSM1900	1850.2~1909.8
	WCDMA BAND II	1852.4~1907.6
	WCDMA BAND V	826.4~846.6
Power Class	GSM850: 4, test with power level 5	
	PCS1900: 1, test with power level 0	
	WCDMA BAND II/V: 3, test with maximum output power	

Air-Interface	Band	RF Performance tested(C63.19)	T-coil Performance tested(C63.19)
GSM	850	yes	yes
	1900	yes	yes
WCDMA	Band II	no	yes
	Band V	no	yes

#### 4.2 Identification of EUT

EUT ID	SN or IMEI	Received Date
TN02	239832165474001	2017-05-10

\*EUT ID: identify the test sample in the lab internally.

#### 4.3 Identification of AE

AE ID*	Description
AE1	Battery
AE2	Travel Adaptor

##### AE1

Model	5501
Manufacturer	SHENZHEN CKYWANDE BATTERY Co.,LTD
Capacitance	3000mAh
Nominal Voltage	3.8V

##### AE2

Model	TPA-46B050100UU
Manufacturer	SHENZHEN TIANYIN ELECTRONICS CO.,LTD.
Length of DC line	0mm with USB connector

\*AE ID: is used to identify the test sample in the lab internally.

## **5. Operational Conditions during Test**

### **5.1 General description of test procedures**

A communication link is set up with a system simulator by air link, and a call is established. The absolute radio frequency channel is allocated to low, middle and high respectively in the case of each band. The EUT is commanded to operate at maximum transmitting power.

Connection to the EUT is established via air interface with CMU200, and the EUT is set to maximum output power by CMU200. The antenna connected to the output of the base station simulator shall be placed at least 50 cm away from the EUT. The signal transmitted by the simulator to the antenna feeding point shall be lower than the output power level of the EUT by at least 30 dB.

### **5.2 GSM Test Configuration**

A communication link is set up with a System Simulator (SS) by air link, and a call is established. The EUT is commanded to operate at maximum transmitting power. Using CMU200 the power level is set to "5" for GSM 850, set to "0" for GSM 1900. The test in the bands of GSM 850 and GSM 1900 are performed in the mode of speech transfer function.

While testing T-coil of GSM, CMU200 set to network/bit stream/handset low.

## **6. HAC Measurements system configuration**

### **6.1 HAC Measurement set-up**

The DASY5 system for performing compliance tests consists of the following items:

- A standard high precision 6-axis robot ( Staubli TX=RX family) with controller, teach pendant and software. An arm extension for accommodating the data acquisition electronics (DAE).
- An isotropic \_field probe optimized and calibrated for the targeted measurement.
- A data acquisition electronics (DAE) which performs the signal amplification, signal multiplexing, AD-conversion, offset measurements, mechanical surface detection, collision detection, etc. The unit is battery powered with standard or rechargeable batteries. The signal is optically transmitted to the EOC.
- The Electro-optical converter (EOC) performs the conversion from optical to electrical signals for the digital communication to the DAE. To use optical surface detection, a special version of the EOC is required. The EOC signal is transmitted to the measurement server.
- The function of the measurement server is to perform the time critical tasks such as signal filtering, control of the robot operation and fast movement interrupts.
- The Light Beam used is for probe alignment. This improves the (absolute) accuracy of the probe positioning.
- A computer running WinXP and the DASY5 software.
- Remote control and teach pendant as well as additional circuitry for robot safety such as warning lamps, etc.
- The generic twin phantom enabling the testing of left-hand and right-hand usage.
- The device holder for handheld mobile phones.
- Tissue simulating liquid mixed according to the given recipes.
- System validation dipoles allowing to validate the proper functioning of the system.

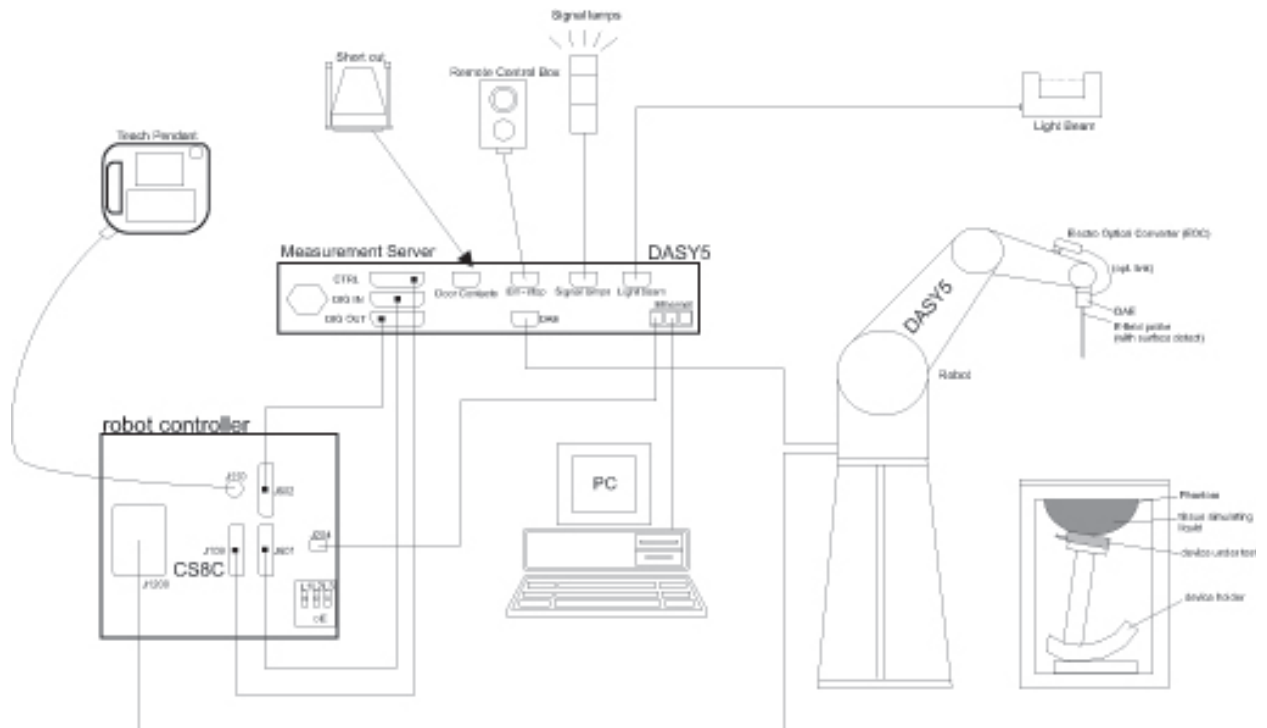


Figure 1. SAR Lab Test Measurement Set-up

## 6.2. DASYS5 Isotropic Probe System

The HAC measurements were conducted with the dosimetric probe ER3DV6 , H3DV6 , Active Audio Magnetic Field Probe AM1DV3 (manufactured by SPEAG), designed in the classical triangular configuration and optimized for dosimetric evaluation.

### 6.2.1. Calibration of RF E-field probes

The purpose of the calibration for probe modulation response factor is to align the probe readings with the quantity of the RF signal most closely correlated with the intensity of interference to hearing aids. Probes used for measuring near-field emissions and calibrating immunity field levels shall be calibrated using the guidelines contained in IEEE Std 1309-2005. The field pattern shall be isotropic to a tolerance of  $\pm 20\%$ . If probes with coaxial cables are used, the influence of cables on the field shall be accounted for in the calibration. The H-field probe may have one, two, or three loops. In the case where these probes have less than three mutually orthogonal dipoles or loops, they shall be capable of rotation about their geometric centers to allow calibration and measurement in the three orthogonal axes. IEEE Std 1309-2005 provides for three calibration methods and several grades of calibration. The two methods that are most appropriate for ANSI C63.19 probe calibrations are Method A, using a transfer standard probe, or Method B, using a standard gain horn antenna in an anechoic chamber. The most appropriate grade of calibration is: FD, F2 (fL, fM, fH), 57 A1, I0 for single-axis probes or I1 for "isotropic" probes, R0, T0, and M0. The grade designations are found in Annex A of IEEE Std 1309-2005.

The “maximum interception alignment” as defined and specified in 4.2.2.1 of IEEE Std 1309-2005 shall be used for calibration. The calibration field generation shall be via a pyramidal horn antenna in an anechoic chamber, either as a standard gain antenna, Method B (Table 2 of IEEE Std 1309-2005), or as a reference field generator using a similar probe as a transfer standard, Method A (Table 2 of IEEE Std 1309-2005). Anisotropy of “isotropic” probes shall be measured in accordance with 7.1.3 and

Equation (2) of IEEE Std 1309-2005.

The best-case expanded uncertainty,  $U$ , for probe calibration is  $U \approx \pm 1.1$  dB for Method A and  $U \approx \pm 1.0$  dB for Method B. Out of the allowable expanded uncertainty of  $\pm 2$  dB (see 4.1.2), these calibration uncertainties leave approximately  $\pm 0.84$  dB to  $\pm 0.86$  dB in terms of combined standard uncertainty,  $u_C$ , for other contributors. That is:  $U = \pm 2$  dB, thus

$u_C = \pm 2 \div 2 = \pm 1$  dB;  $U_s^2 = u_C^2 - u_{cal}^2$ ;  $u_{cal} = u_{cal} \div 2 = \pm 1.1 \div 2 = \pm 0.55$  dB (the value,  $u_{cal} = \pm 1.1$  dB, is from Method A); and,  $U_s = \sqrt{(2 - 0.552)} = \pm 0.84$  dB.



**Figure 2.ER3DV6 E-field Probe**

### 6.2.2. RF field Probe modulation response

In addition, for probes with a response to variations in the RF field of  $< 20$  kHz, a calibration shall be made of the modulation response of the probe and its instrumentation chain. This calibration shall be performed with the field probe attached to the instrumentation that is to be used with it during the measurement. The response of the probe system to a CW field at the frequency(s) of interest is compared to its response to a modulated signal with equal amplitude. The field level of the test signals shall be more than 10 dB above the ambient level and the noise floor of the instrumentation being used. The ratio of the CW reading to that taken with a modulated field shall be applied to the readings taken of modulated fields of the specified type.

This may be done using the following procedure:

- 1) Fix the probe in a set location relative to a field generating device, such as a reference dipole antenna or WB TEM,
- 2) Illuminate the probe with a CW signal at the intended measurement frequency.
- 3) Record the reading of the probe measurement system of the CW signal.
- 4) Record the power level of the CW signal being used to drive the field generating device.

- 5) Substitute a signal using the same modulation as that used by the intended WD for the CW signal.
- 6) Set the amplitude during transmission of the modulated signal to equal the amplitude of the CW signal.
- 7) Record the modulated signal reading from the probe measurement system.
- 8) The ratio, in linear units, of the CW to modulated signal reading is the modulation factor.

### **6.3. Other Test Equipment**

#### **6.3.1. Validation of dipoles**

##### **Equipment**

- 1) Broadband dipoles 800 MHz to 950 MHz or 1.6 GHz to 2.5 GHz
- 2) Signal generator
- 3) RF amplifier
- 4) Calibrated E-field probes
- 5) Appropriate test location, i.e., anechoic room or at least a test area large enough so that reflections off of nearby objects do not disturb the test results

##### **Validation procedure**

- 1) Connect equipment as shown in Figure 4.  
Position the E-field probe at a 15 mm distance from the top surface of the dipole, which is also fixed in an appropriate fixture (Figure C.1). A gauge block, like that shown in Figure A.3, may be used to set the 15 mm distance accurately.
- 2) Make sure that the desired measuring channel of the probe is aligned for maximum reception of the E-field generated by the dipole. This may be accomplished by rotating the probe until the maximum value is located. The E-field probe shall have been calibrated over the frequency range to be measured using standard calibration techniques.
- 3) Adjust the power level of the signal generator at the initial starting frequency such that the desired E-field strength at the 15 mm distance from the tip of the dipole is achieved. Setting the field strength to be in the range of category M2 is advised; see Table 5.1 for representative values.
- 4) Step the frequency in increments of  $\leq 1\%$ , adjusting the power fed into the dipole such that the desired E-field strength is maintained.
- 5) Record the frequency and signal generator setting at each frequency for use during the actual immunity test. A sample calibration chart is provided in Table C.1, as an example. If the dipole has a broadband matching section, check that the VSWR is within the specified VSWR over the test band. Tune the dipole or adjust the matching section, if necessary, to achieve better matching..

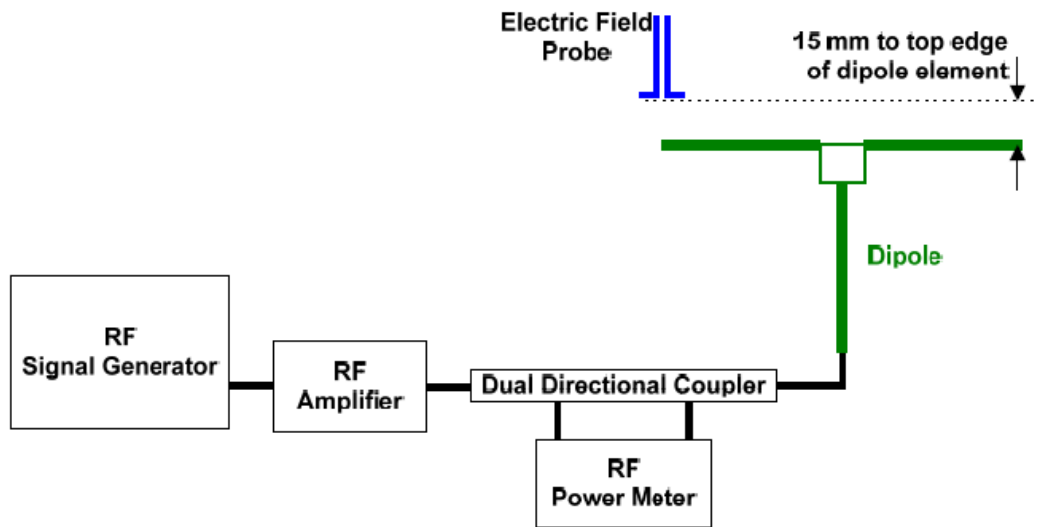


Figure 4. Dipole validation procedure

### 6.3.2. Device Holder for Transmitters

The DASY device holder is designed to cope with the die rent positions given in the standard. It has two scales for device rotation (with respect to the body axis) and device inclination (with respect to the line between the ear reference points). Thus the device needs no repositioning when changing the angles. The amount of dielectric material has been reduced in the closest vicinity of the device, since measurements have suggested that the inference of the clamp on the test results could thus be lowered.

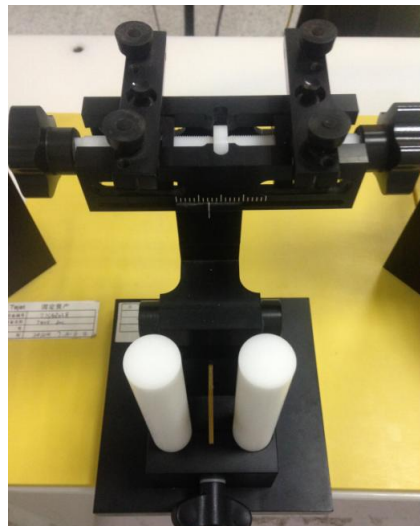


Figure 5. Device Holder

## 6.4. Detailed Near-field Test Procedure

### Pre-test procedure

The following steps shall be performed before the WD near-field emissions test is performed (see



Figure 6). However, these steps need not be performed before every test. They shall be performed periodically, consistent with good laboratory practice and as required, for example, before testing types of WDs not assessed previously at a laboratory.

- 1) Check for probe positioning system repeatability and accuracy.
- 2) Confirm interference of reflective objects is less than  $-20$  dB of the intended signal. This may be done by performing the same measurements on the same WD using multiple WD positions and orientations. The readings shall not differ, due to reflections, by more than  $\pm 0.8$  dB.

### Pre-Test Instructions

Confirm calibration of field probes is current

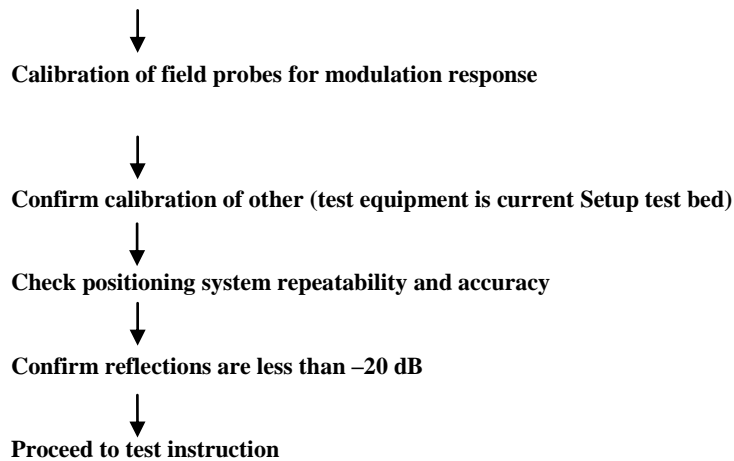


Figure 6—WD near-field emissions pre-test flowchart

## 6.5. Data Storage and Evaluation

### 6.5.1. Data Storage

The DASY5 software stores the acquired data from the data acquisition electronics as raw data (in microvolt readings from the probe sensors), together with all necessary software parameters for the data evaluation (probe calibration data, liquid parameters and device frequency and modulation data) in measurement files with the extension “.DA4”. The software evaluates the desired unit and format for output each time the data is visualized or exported. This allows verification of the complete software setup even after the measurement and allows correction of

incorrect parameter settings. For example, if a measurement has been performed with a wrong crest factor parameter in the device setup, the parameter can be corrected afterwards and the data can be re-evaluated. The measured data can be visualized or exported in different units or formats, depending on the selected probe type ([V/m], [A/m], [°C], [mW/g], [mW/cm²], [dBrel], etc.). Some of these units are not available in certain situations or show meaningless results, e.g., a SAR output in a lossless media will always be zero. Raw data can also be exported to perform the evaluation with other software packages.

### 6.5.2. Data Evaluation by SEMCAD

The SEMCAD software automatically executes the following procedures to calculate the field units from the microvolt readings at the probe connector. The parameters used in the evaluation are stored in the configuration modules of the software:

- |                    |                           |                      |
|--------------------|---------------------------|----------------------|
| Probe parameters:  | - Sensitivity             | Normi, ai0, ai1, ai2 |
|                    | - Conversion factor       | ConvFi               |
|                    | - Diode compression point | Dcpi                 |
| Device parameters: | - Frequency f             |                      |
|                    | - Crest factor cf         |                      |
| Media parameters:  | - Conductivity            |                      |
|                    | - Density                 |                      |

These parameters must be set correctly in the software. They can be found in the component documents or they can be imported into the software from the configuration files issued for the DASY5 components. In the direct measuring mode of the multimeter option, the parameters of the actual system setup are used. In the scan visualization and export modes, the parameters stored in the corresponding document files are used.

The first step of the evaluation is a linearization of the filtered input signal to account for the compression characteristics of the detector diode. The compensation depends on the input signal, the diode type and the DC-transmission factor from the diode to the evaluation electronics. If the exciting field is pulsed, the crest factor of the signal must be known to correctly compensate for peak power. The formula for each channel can be given as:

$$V_i = U_i + U_i^2 \cdot c f / d c p_i$$

With  $V_i$  = compensated signal of channel i (i = x, y, z)

$U_i$  = input signal of channel i (i = x, y, z)

$cf$  = crest factor of exciting field (DASY parameter)

$dcp_i$  = diode compression point (DASY parameter)

From the compensated input signals the primary field data for each channel can be evaluated:

E-field probes:  $E_i = (V_i / Norm_i \cdot ConvF)^{1/2}$

H-field probes:  $H_i = (V_i)^{1/2} \cdot (a_{i0} + a_{i1} f + a_{i2} f^2) / f$

With  $V_i$  = compensated signal of channel i (i = x, y, z)

$Norm_i$  = sensor sensitivity of channel i (i = x, y, z)  
[mV/(V/m)<sup>2</sup>] for E-field Probes

$ConvF$  = sensitivity enhancement in solution

$a_{ij}$  = sensor sensitivity factors for H-field probes

$f$  = carrier frequency [GHz]

$E_i$  = electric field strength of channel i in V/m

$H_i$  = magnetic field strength of channel i in A/m

The RSS value of the field components gives the total field strength (Hermitian magnitude):

$$E_{tot} = (E_x^2 + E_y^2 + E_z^2)^{1/2}$$

The primary field data are used to calculate the derived field units.

$$SAR = (E_{tot}^2 \cdot \sigma) / (\rho \cdot 1000)$$

with  $SAR$  = local specific absorption rate in mW/g

$E_{tot}$  = total field strength in V/m

$\sigma$  = conductivity in [mho/m] or [Siemens/m]

$\rho$  = equivalent tissue density in g/cm<sup>3</sup>

Note that the density is normally set to 1 (or 1.06), to account for actual brain density rather than the density of the simulation liquid. The power flow density is calculated assuming the excitation field to be a free space field.

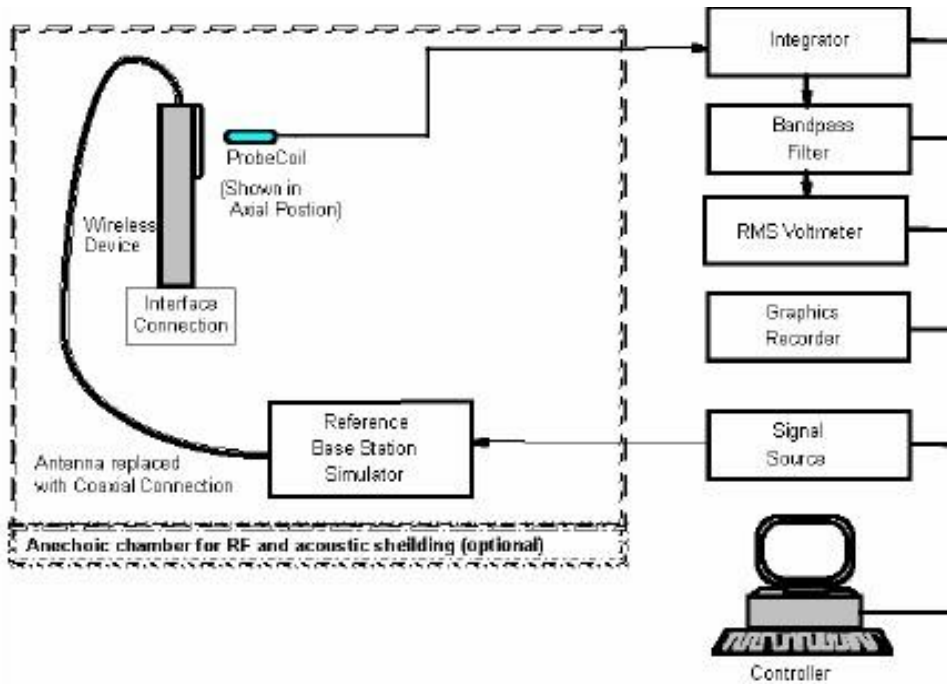
$$P_{pwe} = E_{tot}^2 / 3770 \quad \text{or} \quad P_{pwe} = H_{tot}^2 \cdot 37.7$$

with  $P_{pwe}$  = equivalent power density of a plane wave in mW/cm<sup>2</sup>

$E_{tot}$  = total electric field strength in V/m

$H_{tot}$  = total magnetic field strength in A/m

### 6.6. T-coil Test



**Figure 8. T-coil measurement test Set-up**

A base station simulator, as shown in test setup Figure 6.1, allows the WD to be in its conversation mode. It is required that the base station simulator provide the complementary audio signal processing to the WD. Through the base station simulator, command the WD to transmit at maximum RF power.

NOTE—The WD is set to transmit at maximum RF power to ensure that associated baseband effects such as battery surge currents are accounted for. However, the WD antenna is replaced by a coax so as to mask the effects of the RF transmission signal from the measurement. Set the base station simulator to provide a low-level RF signal, approximately  $-50$  dBm, using a frequency near the center of the frequency band. Inject a P.50 artificial speech signal, or similar speech signal in accordance with 9), for the digital mode.

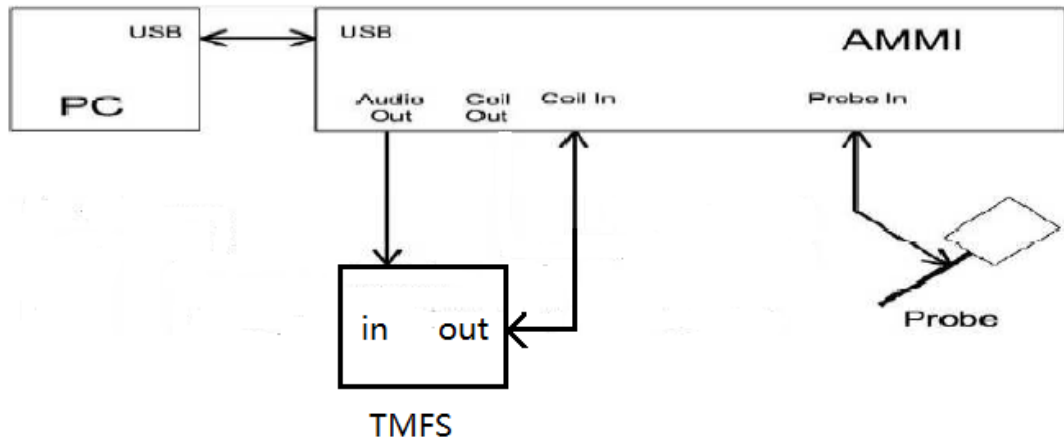


Figure 9. T-coil validation Set-up

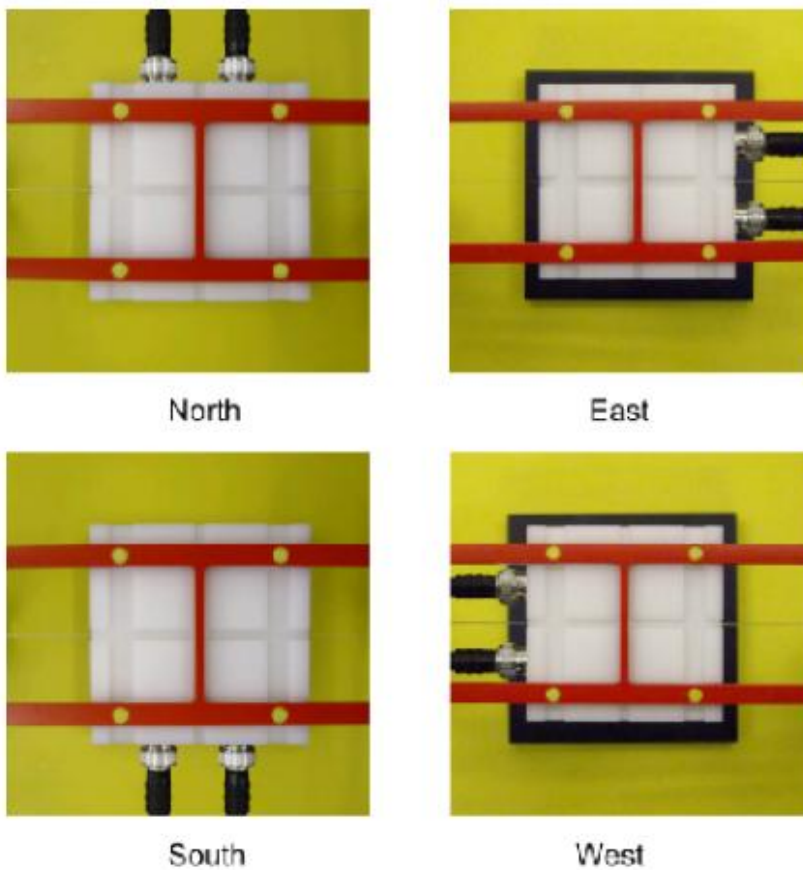


Figure 10. TMFS for T-coil validation Set-up 4 positions

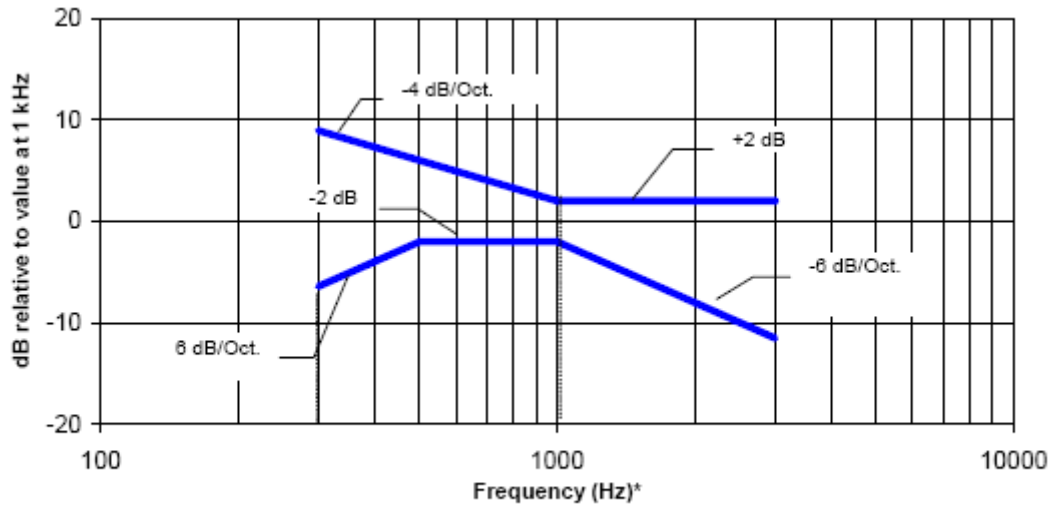
### 6.6.1 T-Coil coupling field intensity

When measured as specified in this standard, the T-Coil signal shall be  $\geq -18$  dB (A/m) at 1 kHz, in a 1/3 octave band filter for all orientations.

### 6.6.2 Frequency response

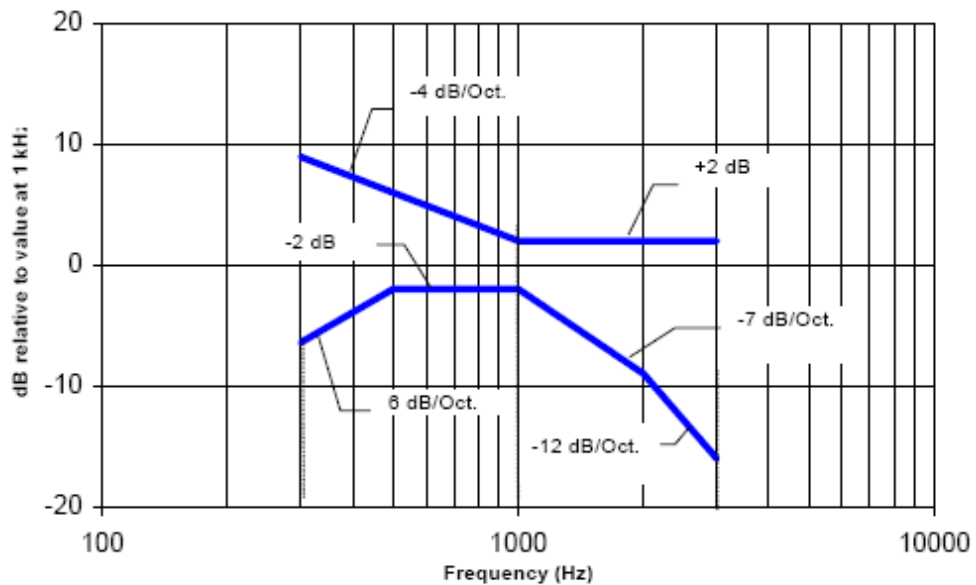
The frequency response of the perpendicular component of the magnetic field, measured in 1/3 octave bands, shall follow the response curve specified in this subclause, over the frequency range 300 Hz to 3000 Hz.

Figure 11 and Figure 12 provide the boundaries as a function of frequency. These response curves are for true field-strength measurements of the T-Coil signal. Thus, the 6 dB/octave probe response has been corrected from the raw readings.



NOTE—Frequency response is between 300 Hz and 3000 Hz.

Figure 11 Magnetic field frequency response for EUTs with a field  $\leq -15$  dB (A/m) at 1 kHz



NOTE—Frequency response is between 300 Hz and 3000 Hz.

Figure 12 Magnetic field frequency response for EUTs with a field that exceeds  $-15$  dB(A/m) at 1 kHz

## 6.7. Modulation interference factor

The HAC Standard ANSI C63.19-2011 defines a new Scaling using the Modulation Interference Factor (MIF)

For any specific fixed and repeatable modulated signal, a modulation interference factor (MIF, expressed in dB) may be developed that relates its interference potential to its steady-state rms signal level or average power level. This factor is a function only of the audio-frequency amplitude modulation characteristics of the signal and is the same for field-strength and conducted power measurements. It is important to emphasize that the MIF is valid only for a specific repeatable audio-frequency amplitude modulation characteristic. Any change in modulation characteristic requires determination and application of a new MIF.

The MIF may be determined using a radiated RF field, a conducted RF signal, or in a preliminary stage, a mathematical analysis of a modeled RF signal:

- a) Verify the slope accuracy and dynamic range capability over the desired operating frequency band of a fast probe or sensor, square-law detector, as specified in D.3, and weighting system as specified in D.4 and D.5. For the probe and instrumentation included in the measurement of MIF, additional calibration and application of calibration factors are not required.
- b) Using RF illumination or conducted coupling, apply the specific modulated signal in question to the measurement system at a level within its confirmed operating dynamic range.
- c) Measure the steady-state rms level at the output of the fast probe or sensor.
- d) Measure the steady-state average level at the weighting output.
- e) Without changing the square-law detector or weighting system, and using RF illumination or conducted coupling, substitute for the specific modulated signal a 1 kHz, 80% amplitude modulated carrier at the same frequency and adjust its strength until the level at the weighting output equals the step d) measurement.
- f) Without changing the carrier level from step e), remove the 1 kHz modulation and again measure the steady-state rms level indicated at the output of the fast probe or sensor.
- g) The MIF for the specific modulation characteristic is provided by the ratio of the step f) measurement to the step c) measurement, expressed in dB ( $20 \times \log(\text{step f})/\text{step c}$ ).

MIF values applied in this test report were provided by the HAC equipment provider, SPEAG, and the values are listed below

UID	Communication System Name	MIF(dB)
10021	GSM-FDD(TDMA,GMSK)	3.63
10011	UMTS-FDD(WCDMA)	-27.23
10039	CDMA2000 (1xRTT, RC1)	-19.77
10081	CDMA2000 (1xRTT, RC3)	-19.71
10295	CDMA2000 (1xRTT, RC1 SO3, 1/8th Rate 25 fr.)	3.26
10100	LTE-FDD(SC-FDMA,100%RB,20MHz,QPSK)	-23.48
10101	LTE-FDD(SC-FDMA,100%RB,20MHz,16-QAM)	-17.86
10108	LTE-FDD(SC-FDMA,100%RB,10MHz,QPSK)	-21.57
10109	LTE-FDD(SC-FDMA,100%RB,10MHz,16-QAM)	-16.87
10110	LTE-FDD(SC-FDMA,100%RB,5MHz,QPSK)	-23.39
10111	LTE-FDD(SC-FDMA,100%RB,5MHz,16-QAM)	-16.35
10139	LTE-FDD(SC-FDMA,100%RB,15MHz,QPSK)	-18.25
10140	LTE-FDD(SC-FDMA,100%RB,15MHz,16-QAM)	-19.37
10142	LTE-FDD(SC-FDMA,100%RB,3MHz,QPSK)	-22.36
10143	LTE-FDD(SC-FDMA,100%RB,3MHz,16-QAM)	-14.75
10145	LTE-FDD(SC-FDMA,100%RB,1.4MHz,QPSK)	-17.39
10146	LTE-FDD(SC-FDMA,100%RB,1.4MHz,16-QAM)	-13.6
10148	LTE-FDD(SC-FDMA,50%RB,20MHz,QPSK)	-18.28
10149	LTE-FDD(SC-FDMA,50%RB,20MHz,16-QAM)	-16.87
10154	LTE-FDD(SC-FDMA,50%RB,10MHz,QPSK)	-23.42
10155	LTE-FDD(SC-FDMA,50%RB,10MHz,16-QAM)	-16.36
10156	LTE-FDD(SC-FDMA,50%RB,5MHz,QPSK)	-21.71
10157	LTE-FDD(SC-FDMA,50%RB,5MHz,16-QAM)	-15.78
10160	LTE-FDD(SC-FDMA,50%RB,15MHz,QPSK)	-17.95
10161	LTE-FDD(SC-FDMA,50%RB,15MHz,16-QAM)	-17.54
10163	LTE-FDD(SC-FDMA,50%RB,3MHz,QPSK)	-19.99
10164	LTE-FDD(SC-FDMA,50%RB,3MHz,16-QAM)	-14.41
10166	LTE-FDD(SC-FDMA,50%RB,1.4MHz,QPSK)	-18.1
10167	LTE-FDD(SC-FDMA,50%RB,1.4MHz,16-QAM)	-12.15
10169	LTE-FDD(SC-FDMA,1RB,20MHz,QPSK)	-15.63
10170	LTE-FDD(SC-FDMA,1RB,20MHz,16-QAM)	-9.76
10175	LTE-FDD(SC-FDMA,1RB,10MHz,QPSK)	-15.63
10176	LTE-FDD(SC-FDMA,1RB,10MHz,16-QAM)	-9.76
10177	LTE-FDD(SC-FDMA,1RB,5MHz,QPSK)	-15.63
10178	LTE-FDD(SC-FDMA,1RB,5MHz,16-QAM)	-9.76
10181	LTE-FDD(SC-FDMA,1RB,15MHz,QPSK)	-15.63
10182	LTE-FDD(SC-FDMA,1RB,15MHz,16-QAM)	-9.76
10184	LTE-FDD(SC-FDMA,1RB,3MHz,QPSK)	-15.62
10185	LTE-FDD(SC-FDMA,1RB,3MHz,16-QAM)	-9.76
10187	LTE-FDD(SC-FDMA,1RB,1.4MHz,QPSK)	-15.62
10188	LTE-FDD(SC-FDMA,1RB,1.4MHz,16-QAM)	-9.76

The MIF measurement uncertainty is estimated as follows, declared by HAC equipment provider SPEAG, for modulation frequencies from slotted waveforms with fundamental frequency and at least 2 harmonics within 10 kHz:

- i) 0.2 dB for MIF: -7 to +5 dB
- ii) 0.5 dB for MIF: -13 to +11 dB
- iii) 1 dB for MIF: >-20 dB



### 6.8. Low-power Exemption

Max Tune-up Limit

Operation Mode		Average Power(dBm)
GSM	GSM850	32.5
	GSM1900	29.0
WCDMA	Band II	21.5
	Band V	22.5

Low-power Exemption

Band	Maximum Average Power(dBm)	Worst case MIF(dB)	Power+MIF (dB)	C63.19 test required
GSM850	32.5	3.63	36.13	Yes
GSM1900	29.0	3.63	32.63	Yes
WCDMA Band II	21.5	-27.23	-5.73	No
WCDMA Band V	22.5	-27.23	-4.73	No

#### According to ANSI C63.19 2011 4.4

RF air interface technologies that have low power have been found to produce sufficiently low RF interference potential, so that it is possible to exempt them from the product testing specified in Clause 5. as described in 5.4.4. An RF air interfacetechnology of a device is exempt from testing when its average antenna input power plus its MIF is  $\leq 17$  dBm for any of its operating modes.

### 6.9. Limits of HAC RF and T-coil

RF E-field category

Emission categories	E-Field Emissions (V/m) < 960MHz
Category M1	50 to 55 dB(V/m)
Category M2	45 to 50 dB(V/m)
Category M3	40 to 45 dB(V/m)
Category M4	<40 dB(V/m)
Emission categories	E-Field Emissions (V/m) > 960MHz
Category M1	40 to 45 dB(V/m)
Category M2	35 to 40 dB(V/m)
Category M3	30 to 35 dB(V/m)
Category M4	<30 dB(V/m)

T-coil category

<b>Category</b>	<b>Telephone parameters WD signal quality [(signal+noise)-to-noise ratio in decibels]</b>
Category T1	0 dB to 10 dB
Category T2	10 dB to 20 dB
Category T3	20 dB to 30 dB
Category T4	> 30 dB

## 7. Conducted Output Power Measurement

### 7.1. Summary

The DUT is tested using an CMU200 communications tester as controller unit to set test channels and maximum output power to the DUT, as well as for measuring the conducted power. Conducted output power was measured using an integrated RF connector and attached RF cable. This result contains conducted output power for the EUT.

### 7.2. Conducted Power Results

GSM850	Conducted power(dBm)		
	Channel 128	Channel 189	Channel 251
Test Result	31.90	31.99	32.09

GSM1900	Conducted power(dBm)		
	Channel 512	Channel 661	Channel 810
Test Result	28.63	28.60	28.60

WCDMA Band II	Conducted power(dBm)		
	Channel 9262	Channel 9400	Channel 9538
12.2kbps RMC	21.39	21.25	21.20

WCDMA Band V	Conducted power(dBm)		
	Channel 4132	Channel 4183	Channel 4233
12.2kbps RMC	22.28	22.21	22.05

## 8. Test Results

### 8.1. System Check Results

#### System Check for RF E-field

Frequency	Description	Measurement Result	
		E-Field dB(V/m)	Div(%)
835MHz	Recommended result	108.0	\
	±10% window	97.2-118.8	
	Measurement value 2017-05-12	103.2	-4.65
1880MHz	Recommended result	90.2	\
	±10% window	81.18-98.22	
	Measurement value 2017-05-12	88.16	-2.31

Note: 1. the graph results see ANNEX E.

2. Recommended Values used derive from the calibration certificate and 100 mW is used as feeding power to the calibrated dipole.

## 8.2. Test Results

### 8.2.1. Summary of HAC RF Measurement Results

Test Case		Measurement Result	
Band	Channel	Max E-Field(V/m)	Category
GSM850	Low/128	34.94	M4
	Mid/189	35.32	M4
	High/251	35.39	M4

Test Case		Measurement Result	
Band	Channel	Max E-Field(V/m)	Category
GSM1900	Low/512	27.16	M4
	Mid/661	28.64	M4
	High/810	29.93	M4

### 8.2.2. Summary of HAC T-COIL Measurement Results

BAND	CH	Probe Position	Measurement position (x mm,y mm)	ABM1 (dB(A/m))	SNR (dB)	Frequency Response	T Category
GSM850	189	Radial (transversal)	-4.2,-8.3	-10.89	29.41	pass	T3
		Axial	0,0	0.03	20.22		T3

BAND	CH	Probe Position	Measurement position (x mm,y mm)	ABM1 (dB(A/m))	SNR (dB)	Frequency Response	T Category
GSM1900	661	Radial (transversal)	0,-8.3	-6.87	32.26	pass	T4
		Axial	0,-4.2	-0.19	23.66		T3

BAND	CH	Probe Position	Measurement position (x mm,y mm)	ABM1 (dB(A/m))	SNR (dB)	Frequency Response	T Category
WCDMA Band II	9400	Radial (transversal)	0,-8.3	-6.63	34.91	pass	T4
		Axial	0,-4.2	0.09	40.50		T4

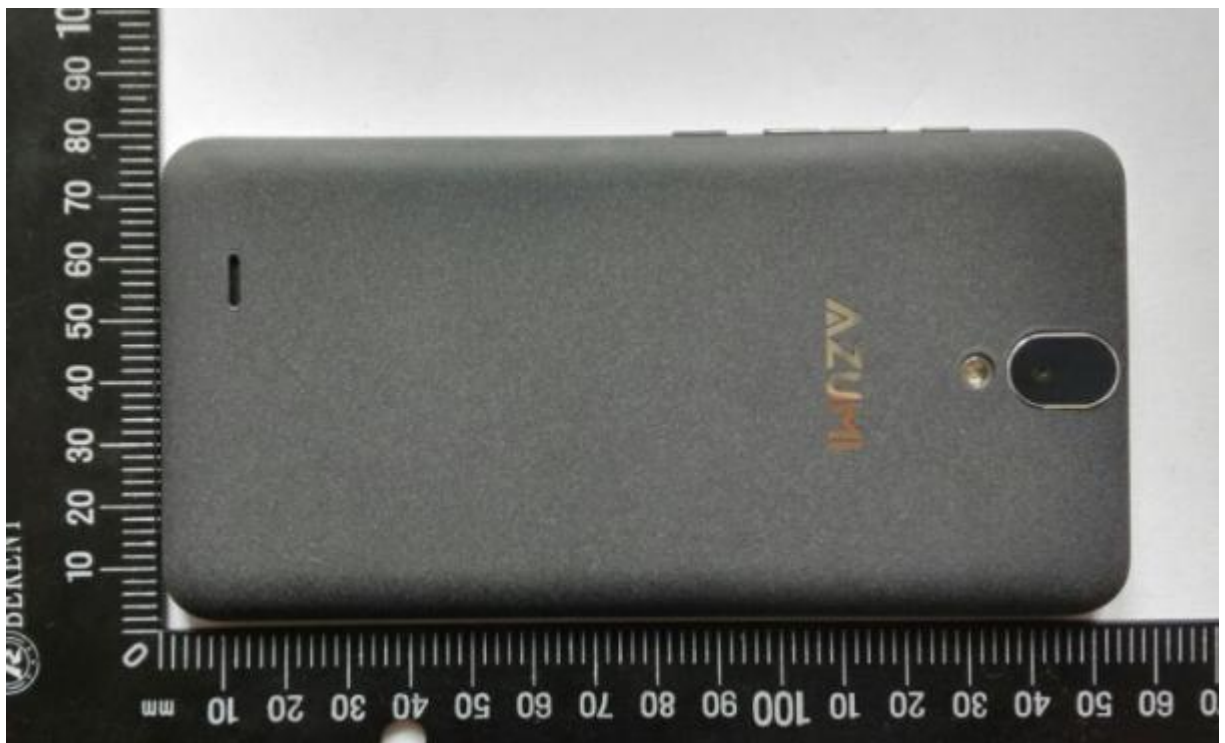
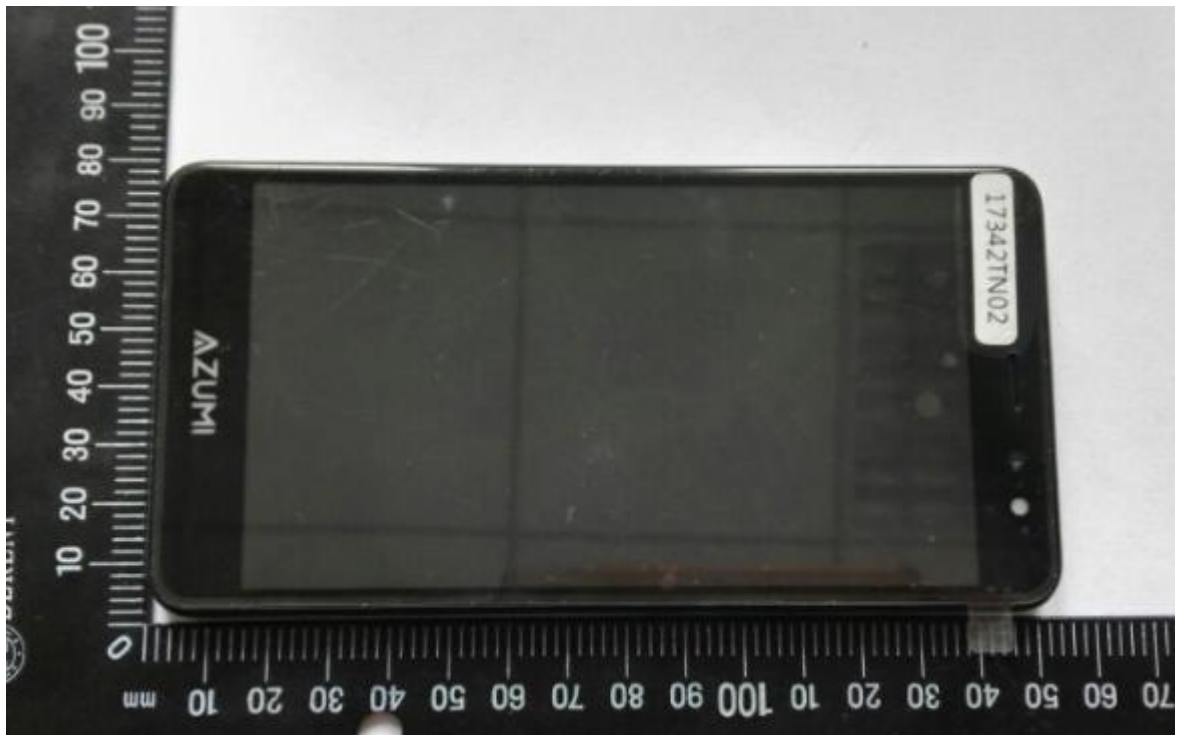
BAND	CH	Probe Position	Measurement position (x mm,y mm)	ABM1 (dB(A/m))	SNR (dB)	Frequency Response	T Category
WCDMA Band V	4183	Radial (transversal)	4.2,-8.3	-6.31	34.96	pass	T4
		Axial	0,0	-0.12	41.94		T4

### 8.3. Conclusion

Band	M-Rating	PASS/FAIL	T-Rating	PASS/FAIL
GSM850	M4	PASS	T3	PASS
GSM1900	M4	PASS	T3	PASS
WCDMA BAND II	M4	PASS	T4	PASS
WCDMA BAND V	M4	PASS	T4	PASS

General Judgment: PASS

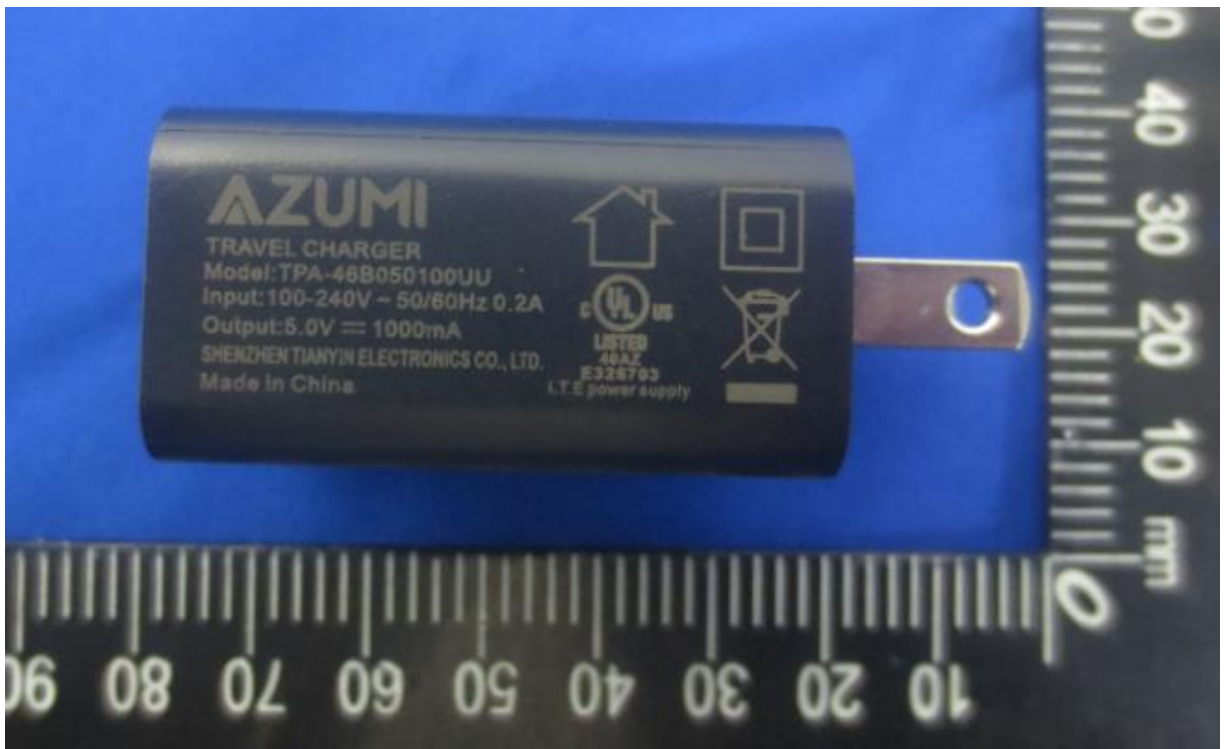
ANNEX A: EUT Photograph



EUT



BATTERY







Travel Adaptor

## ANNEX B: Measurement Uncertainty

HAC Uncertainty Budget According to ANSI C63.19-2011

Error Description	Uncertainty Value	Prob Dist	Div.	(ci) E	Std. Unc. E
<b>Measurement System</b>					
Probe Calibration	5.1%	N	1	1	5.1%
Axial Isotropy	4.7%	R	$\sqrt{3}$	1	2.7%
Sensor Displacement	16.5%	R	$\sqrt{3}$	1	9.5%
Boundary Effects	2.4%	R	$\sqrt{3}$	1	1.4%
Phantom Boundary Effect	7.2%	R	$\sqrt{3}$	1	4.1%
Linearity	4.7%	R	$\sqrt{3}$	1	2.7%
Scaling to Peak Envelope Power	2.0%	R	$\sqrt{3}$	1	1.2%
System Detection Limit	1.0%	R	$\sqrt{3}$	1	0.6%
Readout Electronics	0.3%	N	1	1	0.3%
Response Time	0.8%	R	$\sqrt{3}$	1	0.5%
Integration Time	2.6%	R	$\sqrt{3}$	1	1.5%
RF Ambient Conditions	3.0%	R	$\sqrt{3}$	1	1.7%
RF Reflections	12.0%	R	$\sqrt{3}$	1	6.9%
Probe Positioner	1.2%	R	$\sqrt{3}$	1	0.7%
Probe Positioning	4.7%	R	$\sqrt{3}$	1	2.7%
Extrap. and Interpolation	1.0%	R	$\sqrt{3}$	1	0.6%
<b>Test Sample Related</b>					
Device Positioning Vertical	4.7%	R	$\sqrt{3}$	1	2.7%
Device Positioning Lateral	1.0%	R	$\sqrt{3}$	1	0.6%

Device Holder and Phantom	2.4%	R	$\sqrt{3}$	1	1.4%
Power Drift	5.0%	R	$\sqrt{3}$	1	2.9%
<b>Phantom and Setup Related</b>					
Phantom Thickness	2.4%	R	$\sqrt{3}$	1	1.4%
<b>Combined Std. Uncertainty</b>					14.8%
<b>Expanded Std. Uncertainty(95% k=2)</b>					29.6%

## Uncertainty Budget for HAC T-Coil measurements

Uncertainty of Audio Band Magnetic Measurements							
According to ANSI C63.19-2011							
Error Description	Uncertainty Value	Prob Dist	Div.	(ci) ABM1	(ci) ABM2	Std. Unc. ABM1	Std. Unc. ABM2
<b>Probe Sensitivity</b>							
Reference Level	3.0%	N	1	1	1	3.0%	3.0%
AMCC Geometry	0.4%	R	$\sqrt{3}$	1	1	0.2%	0.2%
AMCC Current	1.0%	R	$\sqrt{3}$	1	1	0.6%	0.6%
Probe Positioning during Calibration.	0.1%	R	$\sqrt{3}$	1	1	0.1%	0.1%
Noise Contribution	0.7%	R	$\sqrt{3}$	0.0143	1	0.0%	0.4%
Frequency Slope	5.9%	R	$\sqrt{3}$	0.1	1.0	0.3%	3.5%
<b>Probe System</b>							
Repeatability / Drift	1.0%	R	$\sqrt{3}$	1	1	0.6%	0.6%
Linearity / Dynamic Range	0.6%	R	$\sqrt{3}$	1	1	0.4%	0.4%
Acoustic Noise	1.0%	R	$\sqrt{3}$	0.1	1	0.1%	0.6%
Probe Angle	2.3%	R	$\sqrt{3}$	1	1	1.4%	1.4%
Spectral Processing	0.9%	R	$\sqrt{3}$	1	1	0.5%	0.5%
Integration Time	0.6%	N	1	1	5	0.6%	3.0%
Field Disturbation	0.2%	R	$\sqrt{3}$	1	1	0.1%	0.1%
<b>Test Signal</b>							
Ref. Signal Spectral Response	0.6%	R	$\sqrt{3}$	0	1	0.0%	0.4%
<b>Positioning</b>							
Probe Positioning	1.9%	R	$\sqrt{3}$	1	1	1.1%	1.1%
Phantom Thickness	0.9%	R	$\sqrt{3}$	1	1	0.5%	0.5%

DUT Positioning	1.9%	R	$\sqrt{3}$	1	1	1.1%	1.1%
<b>External Contributions</b>							
RF Interference	0.0%	R	$\sqrt{3}$	1	0.3	0.0%	0.0%
Test Signal Variation	2.0%	R	$\sqrt{3}$	1	1	1.2%	1.2%
<b>Combined Uncertainty</b>							
<b>Combined Std. Uncertainty (ABM Field)</b>						<b>4.1%</b>	<b>6.1%</b>
<b>Expanded Std. Uncertainty(95% k=2)</b>						<b>8.2%</b>	<b>12.2%</b>

### ANNEX C: Main Test Instruments

No.	Name	Type	Calibration Date	Valid Period
01	Power meter	Agilent E4419B	May 18 <sup>th</sup> , 2016	One year
02	Power sensor A	Agilent 8482A	May 18 <sup>th</sup> , 2016	One year
03	Power sensor B	Agilent 8485D	May 18 <sup>th</sup> , 2016	One year
04	Signal Generator	Agilent N5182A	Oct28 <sup>th</sup> , 2016	One year
05	Amplifier	ZHL-42W	NA	
06	BTS	CMU200	Oct28 <sup>th</sup> , 2016	One year
07	DAE	DAE4	Sep 28 <sup>th</sup> , 2016	One year
08	E-field Probe	ER3DV6	Aug 24 <sup>th</sup> , 2015	Two year
09	T-coil Test Probe	AM1DV3	Aug 25 <sup>th</sup> , 2015	Two year
10	Dipole835MHz	CD835V3	Aug 20 <sup>th</sup> , 2015	Two year
11	Dipole1880MHz	CD1880V3	Aug 20 <sup>th</sup> , 2015	Two year
12	T-coil validation kit	TMFS	NA	

**ANNEX D: Test Layout**



Picture 1: POSITION OF HAC RF



Picture 2: POSITION OF HAC T-Coil



## ANNEX E: HAC System Check Results

### HAC RF SYSTEM CHECK

#### HAC RF E-field system check 835MHz

Date: 12/05/2017

Communication System: UID 0, CW; Communication System Band: ITD835 (835.0 MHz);

Frequency: 835 MHz; Communication System PAR: 0 dB

Medium parameters used:  $\sigma = 0$  S/m,  $\epsilon_r = 1$ ;  $\rho = 0$  kg/m<sup>3</sup>

Phantom section: RF Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY5 Configuration:

- Probe: ER3DV6 - SN2486; ConvF(1, 1, 1); Calibrated: 24/08/2015;
- Sensor-Surface: (Fix Surface), Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sn1226; Calibrated: 28/09/2016
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY52, Version 52.8 (8); SEMCAD X Version 14.6.10 (7331)

**Configuration/E Scan - measurement distance from the probe sensor center to CD835 = 10mm & 15mm/Hearing Aid Compatibility Test at 15mm distance (41x361x1):** Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 115.8 V/m; Power Drift = 0.03 dB

Applied MIF = 0.00 dB

RF audio interference level = 39.42 dBV/m

**Emission category: M4**

MIF scaled E-field

Grid 1 <b>M4</b> <b>39.2 dBV/m</b>	Grid 2 <b>M4</b> <b>39.42 dBV/m</b>	Grid 3 <b>M4</b> <b>39.3 dBV/m</b>
Grid 4 <b>M4</b> <b>35.43 dBV/m</b>	Grid 5 <b>M4</b> <b>35.64 dBV/m</b>	Grid 6 <b>M4</b> <b>35.5 dBV/m</b>
Grid 7 <b>M3</b> <b>40.15 dBV/m</b>	Grid 8 <b>M3</b> <b>40.27 dBV/m</b>	Grid 9 <b>M3</b> <b>40.11 dBV/m</b>

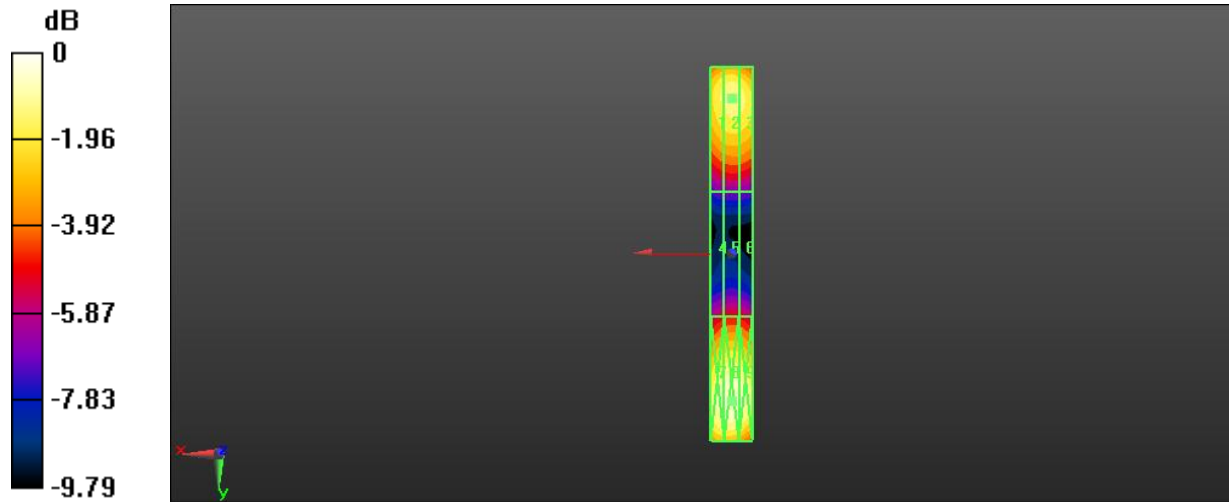
**Cursor:**

Total = 40.27 dBV/m

E Category: M3

Location: 0, 71, 9.7 mm

Maximum value of Total (interpolated) = 103.2 V/m



0 dB = 103.2 V/m = 40.27 dBV/m

**HAC RF E-field system check 1880 MHz**

Date: 12/05/2017

Communication System: UID 0, CW; Communication System Band: CD1880 (1880.0 MHz);

Frequency: 1880 MHz; Communication System PAR: 0 dB

Medium parameters used:  $\sigma = 0$  S/m,  $\epsilon_r = 1$ ;  $\rho = 0$  kg/m<sup>3</sup>

Phantom section: RF Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY5 Configuration:

- Probe: ER3DV6 - SN2486; ConvF(1, 1, 1); Calibrated: 24/08/2015;
- Sensor-Surface: (Fix Surface), Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sn1226; Calibrated: 28/09/2016
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY52, Version 52.8 (8); SEMCAD X Version 14.6.10 (7331)

**Configuration 2/E Scan - measurement distance from the probe sensor center to CD1880 = 10mm & 15mm 2/Hearing Aid Compatibility Test at 15mm distance (41x181x1):** Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 137.1 V/m; Power Drift = 0.01 dB

Applied MIF = 0.00 dB

RF audio interference level = 38.28 dBV/m

**Emission category: M2**

MIF scaled E-field

Grid 1 M2 <b>38.14 dBV/m</b>	Grid 2 M2 <b>38.28 dBV/m</b>	Grid 3 M2 <b>38.16 dBV/m</b>
Grid 4 M2 <b>36.6 dBV/m</b>	Grid 5 M2 <b>36.78 dBV/m</b>	Grid 6 M2 <b>36.69 dBV/m</b>
Grid 7 M2 <b>38.71 dBV/m</b>	Grid 8 M2 <b>38.91 dBV/m</b>	Grid 9 M2 <b>38.75 dBV/m</b>

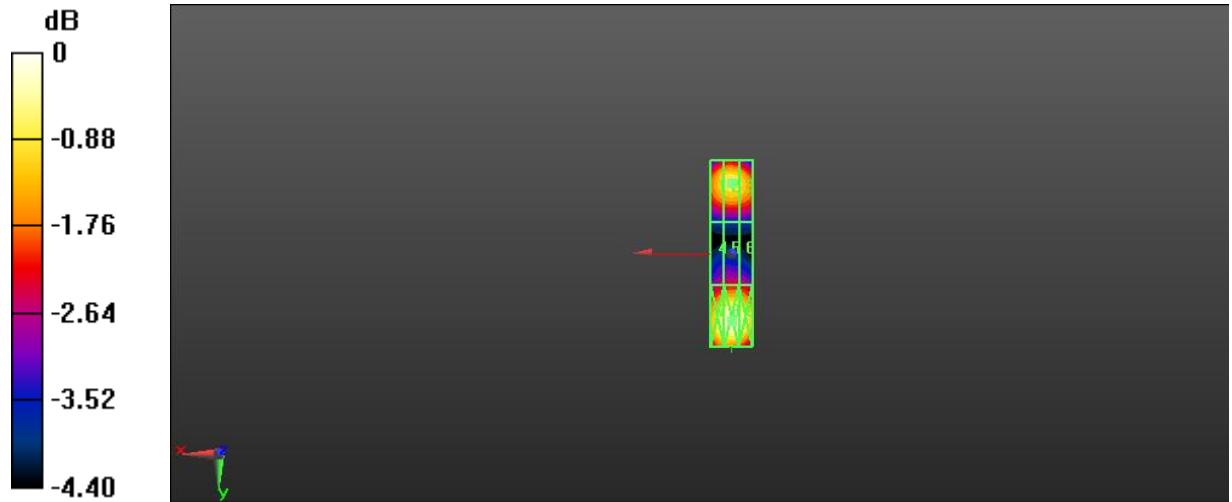
**Cursor:**

Total = 38.91 dBV/m

E Category: M2

Location: 0, 32.5, 9.7 mm

Maximum value of Total (interpolated) = 88.16 V/m



0 dB = 88.16 V/m = 38.91 dBV/m

## ANNEX F: HAC RF Test Results

### HAC RF E-Field

#### GSM850 HAC RF E-field Low

Date: 12/05/2017

Communication System: UID 0, GSM (0); Communication System Band: GSM850(824.0-849.0MHz); Frequency: 824.2 MHz; Communication System PAR: 9.191 dB

Medium parameters used:  $\sigma = 0 \text{ S/m}$ ,  $\epsilon_r = 1$ ;  $\rho = 0 \text{ kg/m}^3$

Phantom section: RF Section

Measurement Standard: DASYS (IEEE/IEC/ANSI C63.19-2011)

DASY5 Configuration:

- Probe: ER3DV6 - SN2486; ConvF(1, 1, 1); Calibrated: 24/08/2015;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn1226; Calibrated: 28/09/2016
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASYS2, Version 52.8 (8); SEMCAD X Version 14.6.10 (7331)

#### GSM850/E Scan - ER3D: 15 mm from Probe Center to the Device/Hearing Aid Compatibility Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 43.85 V/m; Power Drift = -0.07 dB

Applied MIF = 3.63 dB

RF audio interference level = 34.94 dBV/m

**Emission category: M4**

MIF scaled E-field

Grid 1 <b>M4</b> <b>32.95 dBV/m</b>	Grid 2 <b>M4</b> <b>34.75 dBV/m</b>	Grid 3 <b>M4</b> <b>34.75 dBV/m</b>
Grid 4 <b>M4</b> <b>33.08 dBV/m</b>	Grid 5 <b>M4</b> <b>34.94 dBV/m</b>	Grid 6 <b>M4</b> <b>34.93 dBV/m</b>
Grid 7 <b>M4</b> <b>33.23 dBV/m</b>	Grid 8 <b>M4</b> <b>34.82 dBV/m</b>	Grid 9 <b>M4</b> <b>34.81 dBV/m</b>

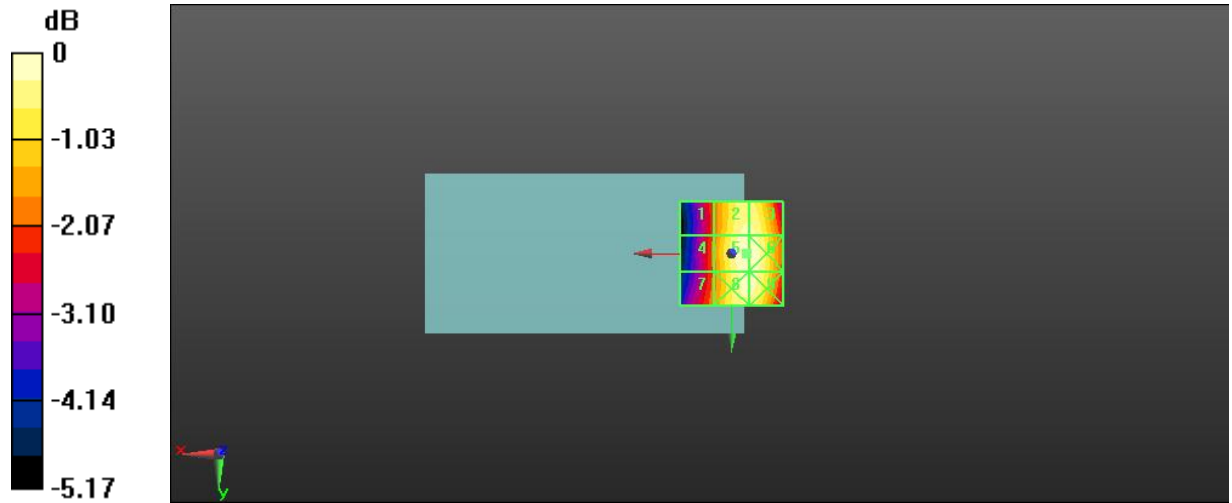
Category	Limits for E-Field Emissions < 960MHz	Limits for E-Field Emissions > 960MHz
M1	50 dBV/m - 55 dB V/m	40 dBV/m - 45 dB V/m
M2	45 dBV/m - 50 dB V/m	35 dBV/m - 40 dB V/m
M3	40 dBV/m - 45 dB V/m	30 dBV/m - 35 dB V/m
M4	<40 dBV/m	<30 dBV/m

**Cursor:**

Total = 34.94 dBV/m

E Category: M4

Location: -7.5, 0, 8.7 mm



0 dB = 55.85 V/m = 34.94 dBV/m

**GSM850 HAC RF E-field Mid**

Date: 12/05/2017

Communication System: UID 0, GSM (0); Communication System Band: GSM850(824.0-849.0MHz); Frequency: 836.6 MHz; Communication System PAR: 9.191 dB

Medium parameters used:  $\sigma = 0$  S/m,  $\epsilon_r = 1$ ;  $\rho = 0$  kg/m<sup>3</sup>

Phantom section: RF Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY5 Configuration:

- Probe: ER3DV6 - SN2486; ConvF(1, 1, 1); Calibrated: 24/08/2015;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn1226; Calibrated: 28/09/2016
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY52, Version 52.8 (8); SEMCAD X Version 14.6.10 (7331)

**GSM850/E Scan - ER3D: 15 mm from Probe Center to the Device 2/Hearing Aid Compatibility Test (101x101x1):** Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 45.75 V/m; Power Drift = -0.03 dB

Applied MIF = 3.63 dB

RF audio interference level = 35.32 dBV/m

**Emission category: M4**

MIF scaled E-field

Grid 1 <b>M4</b> <b>33.3 dBV/m</b>	Grid 2 <b>M4</b> <b>35.11 dBV/m</b>	Grid 3 <b>M4</b> <b>35.1 dBV/m</b>
Grid 4 <b>M4</b> <b>33.44 dBV/m</b>	Grid 5 <b>M4</b> <b>35.32 dBV/m</b>	Grid 6 <b>M4</b> <b>35.3 dBV/m</b>
Grid 7 <b>M4</b> <b>33.57 dBV/m</b>	Grid 8 <b>M4</b> <b>35.2 dBV/m</b>	Grid 9 <b>M4</b> <b>35.2 dBV/m</b>

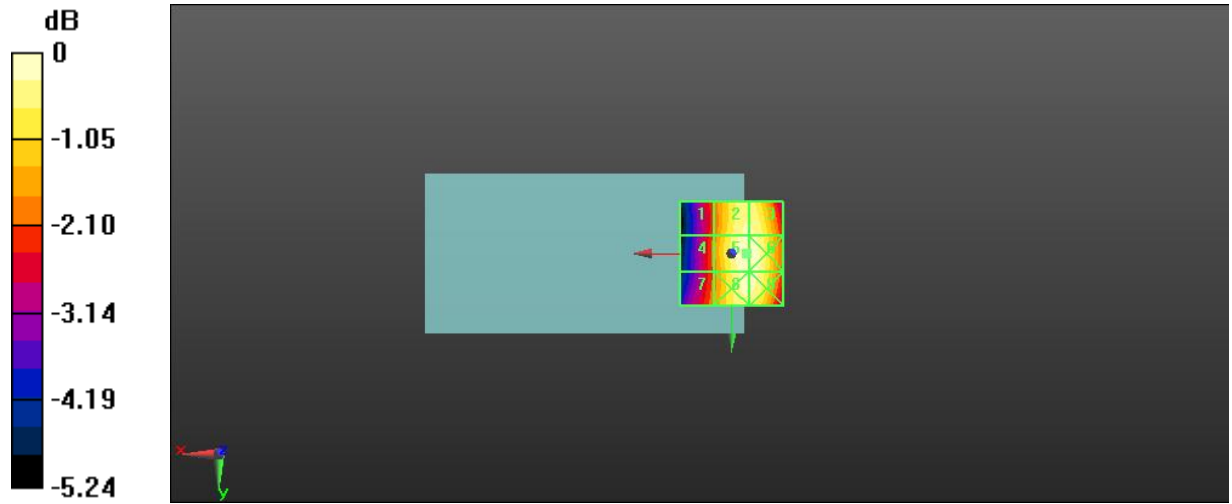
Category	Limits for E-Field Emissions < 960MHz	Limits for E-Field Emissions > 960MHz
M1	50 dBV/m - 55 dB V/m	40 dBV/m - 45 dB V/m
M2	45 dBV/m - 50 dB V/m	35 dBV/m - 40 dB V/m
M3	40 dBV/m - 45 dB V/m	30 dBV/m - 35 dB V/m
M4	<40 dBV/m	<30 dBV/m

**Cursor:**

Total = 35.32 dBV/m

E Category: M4

Location: -7, 0, 8.7 mm



0 dB = 58.33 V/m = 35.32 dBV/m



**GSM850 HAC RF E-field High**

Date: 12/05/2017

Communication System: UID 0, GSM (0); Communication System Band: GSM850(824.0-849.0MHz); Frequency: 848.8 MHz; Communication System PAR: 9.191 dB

Medium parameters used:  $\sigma = 0$  S/m,  $\epsilon_r = 1$ ;  $\rho = 0$  kg/m<sup>3</sup>

Phantom section: RF Section

Measurement Standard: DASYS (IEEE/IEC/ANSI C63.19-2011)

DASY5 Configuration:

- Probe: ER3DV6 - SN2486; ConvF(1, 1, 1); Calibrated: 24/08/2015;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn1226; Calibrated: 28/09/2016
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASYS2, Version 52.8 (8); SEMCAD X Version 14.6.10 (7331)

**GSM850/E Scan - ER3D: 15 mm from Probe Center to the Device 2 2/Hearing Aid Compatibility Test (101x101x1):** Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 45.94 V/m; Power Drift = -0.00 dB

Applied MIF = 3.63 dB

RF audio interference level = 35.39 dBV/m

**Emission category: M4**

MIF scaled E-field

Grid 1 M4 <b>33.34 dBV/m</b>	Grid 2 M4 <b>35.17 dBV/m</b>	Grid 3 M4 <b>35.17 dBV/m</b>
Grid 4 M4 <b>33.53 dBV/m</b>	Grid 5 M4 <b>35.39 dBV/m</b>	Grid 6 M4 <b>35.39 dBV/m</b>
Grid 7 M4 <b>33.7 dBV/m</b>	Grid 8 M4 <b>35.28 dBV/m</b>	Grid 9 M4 <b>35.28 dBV/m</b>

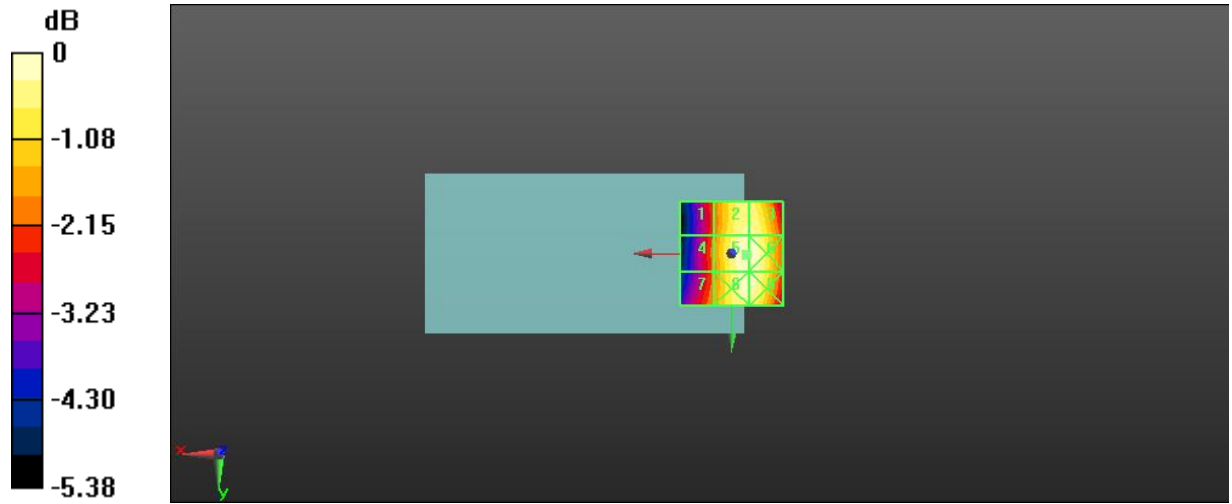
Category	Limits for E-Field Emissions < 960MHz	Limits for E-Field Emissions > 960MHz
M1	50 dBV/m - 55 dB V/m	40 dBV/m - 45 dB V/m
M2	45 dBV/m - 50 dB V/m	35 dBV/m - 40 dB V/m
M3	40 dBV/m - 45 dB V/m	30 dBV/m - 35 dB V/m
M4	<40 dBV/m	<30 dBV/m

**Cursor:**

Total = 35.39 dBV/m

E Category: M4

Location: -7.5, 0.5, 8.7 mm



0 dB = 58.84 V/m = 35.39 dBV/m

**GSM1900 HAC RF E-field Low**

Date: 12/05/2017

Communication System: UID 0, GSM (0); Communication System Band: PCS1900(1850.0-1910.0MHz); Frequency: 1850.2 MHz; Communication System PAR: 9.191 dB

Medium parameters used:  $\sigma = 0$  S/m,  $\epsilon_r = 1$ ;  $\rho = 0$  kg/m<sup>3</sup>

Phantom section: RF Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY5 Configuration:

- Probe: ER3DV6 - SN2486; ConvF(1, 1, 1); Calibrated: 24/08/2015;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn1226; Calibrated: 28/09/2016
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY52, Version 52.8 (8); SEMCAD X Version 14.6.10 (7331)

**GSM1900/E Scan - ER3D: 15 mm from Probe Center to the Device 2 2/Hearing Aid Compatibility Test (101x101x1):** Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 13.76 V/m; Power Drift = -0.04 dB

Applied MIF = 3.63 dB

RF audio interference level = 27.16 dBV/m

**Emission category: M4**

MIF scaled E-field

Grid 1 M4 <b>23.06 dBV/m</b>	Grid 2 M4 <b>23.24 dBV/m</b>	Grid 3 M4 <b>23.45 dBV/m</b>
Grid 4 M4 <b>23.45 dBV/m</b>	Grid 5 M4 <b>27.16 dBV/m</b>	Grid 6 M4 <b>27.18 dBV/m</b>
Grid 7 M4 <b>25.62 dBV/m</b>	Grid 8 M4 <b>28.25 dBV/m</b>	Grid 9 M4 <b>28.25 dBV/m</b>

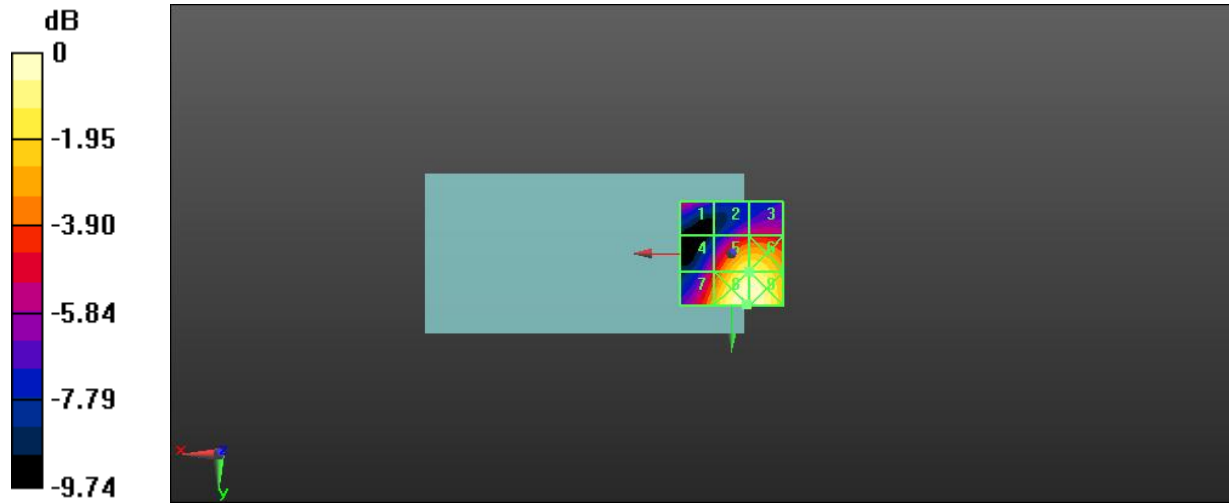
Category	Limits for E-Field Emissions < 960MHz	Limits for E-Field Emissions > 960MHz
M1	50 dBV/m - 55 dB V/m	40 dBV/m - 45 dB V/m
M2	45 dBV/m - 50 dB V/m	35 dBV/m - 40 dB V/m
M3	40 dBV/m - 45 dB V/m	30 dBV/m - 35 dB V/m
M4	<40 dBV/m	<30 dBV/m

**Cursor:**

Total = 28.25 dBV/m

E Category: M4

Location: -7.5, 24.5, 8.7 mm



0 dB = 25.86 V/m = 28.25 dBV/m

**GSM1900 HAC RF E-field Mid**

Date: 12/05/2017

Communication System: UID 0, GSM (0); Communication System Band: PCS1900(1850.0-1910.0MHz); Frequency: 1880 MHz; Communication System PAR: 9.191 dB

Medium parameters used:  $\sigma = 0$  S/m,  $\epsilon_r = 1$ ;  $\rho = 0$  kg/m<sup>3</sup>

Phantom section: RF Section

Measurement Standard: DASYS (IEEE/IEC/ANSI C63.19-2011)

DASY5 Configuration:

- Probe: ER3DV6 - SN2486; ConvF(1, 1, 1); Calibrated: 24/08/2015;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn1226; Calibrated: 28/09/2016
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASYS2, Version 52.8 (8); SEMCAD X Version 14.6.10 (7331)

**GSM1900/E Scan - ER3D: 15 mm from Probe Center to the Device 2 2/Hearing Aid Compatibility Test (101x101x1):** Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 16.31 V/m; Power Drift = 0.09 dB

Applied MIF = 3.63 dB

RF audio interference level = 28.64 dBV/m

**Emission category: M4**

MIF scaled E-field

Grid 1 M4 <b>24.5 dBV/m</b>	Grid 2 M4 <b>25.12 dBV/m</b>	Grid 3 M4 <b>25.37 dBV/m</b>
Grid 4 M4 <b>24.56 dBV/m</b>	Grid 5 M4 <b>28.64 dBV/m</b>	Grid 6 M4 <b>28.67 dBV/m</b>
Grid 7 M4 <b>26.61 dBV/m</b>	Grid 8 M4 <b>29.65 dBV/m</b>	Grid 9 M4 <b>29.65 dBV/m</b>

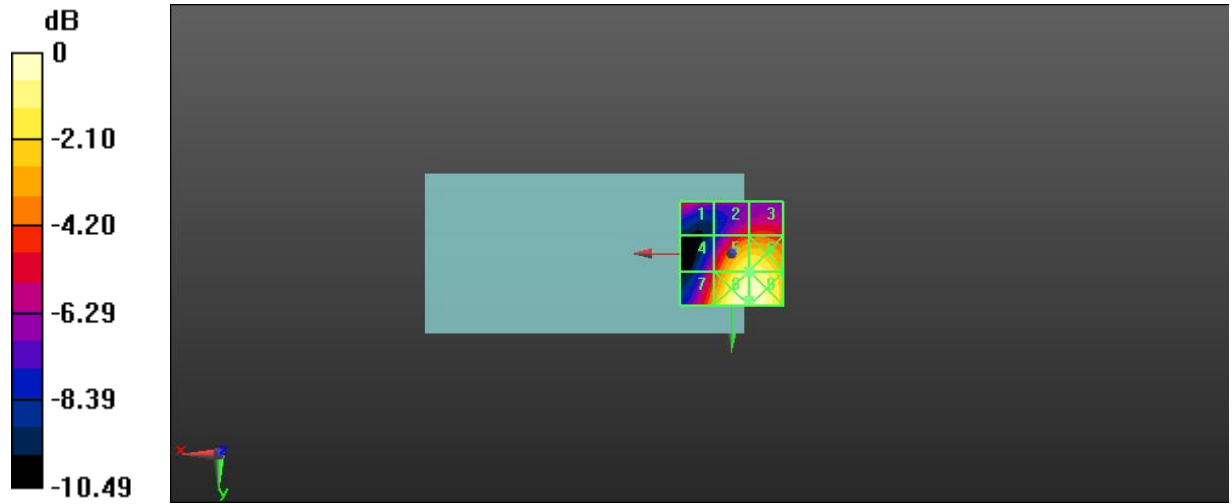
Category	Limits for E-Field Emissions < 960MHz	Limits for E-Field Emissions > 960MHz
M1	50 dBV/m - 55 dB V/m	40 dBV/m - 45 dB V/m
M2	45 dBV/m - 50 dB V/m	35 dBV/m - 40 dB V/m
M3	40 dBV/m - 45 dB V/m	30 dBV/m - 35 dB V/m
M4	<40 dBV/m	<30 dBV/m

**Cursor:**

Total = 29.65 dBV/m

E Category: M4

Location: -8.5, 23, 8.7 mm



0 dB = 30.36 V/m = 29.65 dBV/m

**GSM1900 HAC RF E-field High**

Date: 12/05/2017

Communication System: UID 0, GSM (0); Communication System Band: PCS1900(1850.0-1910.0MHz); Frequency: 1909.8 MHz; Communication System PAR: 9.191 dB

Medium parameters used:  $\sigma = 0$  S/m,  $\epsilon_r = 1$ ;  $\rho = 0$  kg/m<sup>3</sup>

Phantom section: RF Section

Measurement Standard: DASYS (IEEE/IEC/ANSI C63.19-2011)

DASY5 Configuration:

- Probe: ER3DV6 - SN2486; ConvF(1, 1, 1); Calibrated: 24/08/2015;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn1226; Calibrated: 28/09/2016
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASYS2, Version 52.8 (8); SEMCAD X Version 14.6.10 (7331)

**GSM1900/E Scan - ER3D: 15 mm from Probe Center to the Device 2 2 3/Hearing Aid Compatibility Test (101x101x1):** Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 19.54 V/m; Power Drift = -0.00 dB

Applied MIF = 3.63 dB

RF audio interference level = 29.93 dBV/m

**Emission category: M4**

MIF scaled E-field

Grid 1 <b>M4</b> <b>25.68 dBV/m</b>	Grid 2 <b>M4</b> <b>27.28 dBV/m</b>	Grid 3 <b>M4</b> <b>27.52 dBV/m</b>
Grid 4 <b>M4</b> <b>24.78 dBV/m</b>	Grid 5 <b>M4</b> <b>29.93 dBV/m</b>	Grid 6 <b>M3</b> <b>30.03 dBV/m</b>
Grid 7 <b>M4</b> <b>26.04 dBV/m</b>	Grid 8 <b>M3</b> <b>30.34 dBV/m</b>	Grid 9 <b>M3</b> <b>30.4 dBV/m</b>

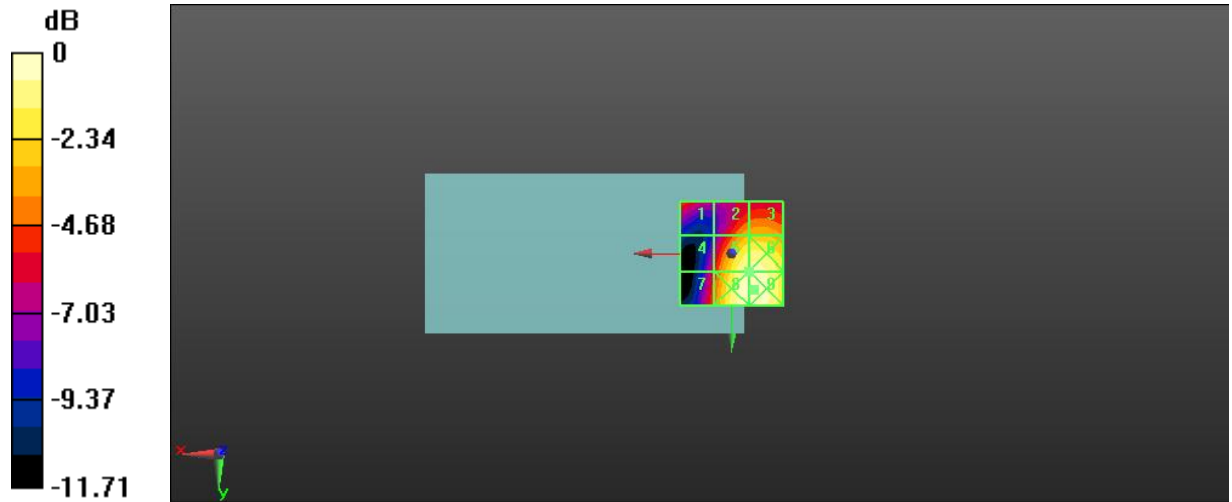
Category	Limits for E-Field Emissions < 960MHz	Limits for E-Field Emissions > 960MHz
M1	50 dBV/m - 55 dB V/m	40 dBV/m - 45 dB V/m
M2	45 dBV/m - 50 dB V/m	35 dBV/m - 40 dB V/m
M3	40 dBV/m - 45 dB V/m	30 dBV/m - 35 dB V/m
M4	<40 dBV/m	<30 dBV/m

**Cursor:**

Total = 30.40 dBV/m

E Category: M3

Location: -10.5, 17.5, 8.7 mm



0 dB = 33.11 V/m = 30.40 dBV/m



## ANNEXG: HAC T-Coil Test Results

### GSM850 T-coil y (transversal)

Date: 11/05/2017

Communication System: UID 0, GSM (0); Communication System Band: GSM850(824.0-849.0MHz); Frequency: 836.6 MHz; Communication System PAR: 9.191 dB

Medium parameters used:  $\sigma = 0$  S/m,  $\epsilon_r = 1$ ;  $\rho = 0$  kg/m<sup>3</sup>

Phantom section: TCoil Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY5 Configuration:

- Probe: AM1DV3 - 3073; ;
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sn1226; Calibrated: 28/09/2016
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY52, Version 52.8 (8); SEMCAD X Version 14.6.10 (7331)

### GSM850/General Scans/y (transversal) 4.2mm 50 x 50/ABM Signal(x,y,z)

(13x13x1): Measurement grid: dx=10mm, dy=10mm

Signal Type: Audio File (.wav) 48k\_voice\_1kHz\_1s.wav

Output Gain: 40.41

Measure Window Start: 300ms

Measure Window Length: 1000ms

BWC applied: 0.16 dB

Device Reference Point: 0, 0, -6.3 mm

#### Cursor:

ABM1 comp = -5.94 dBA/m

BWC Factor = 0.16 dB

Location: 4.2, 4.2, 3.7 mm

### GSM850/General Scans/y (transversal) 4.2mm 50 x 50/ABM SNR(x,y,z)

(13x13x1): Measurement grid: dx=10mm, dy=10mm

Signal Type: Audio File (.wav) 48k\_voice\_1kHz\_1s.wav

Output Gain: 40.41

Measure Window Start: 300ms

Measure Window Length: 1000ms

BWC applied: 0.16 dB

Device Reference Point: 0, 0, -6.3 mm

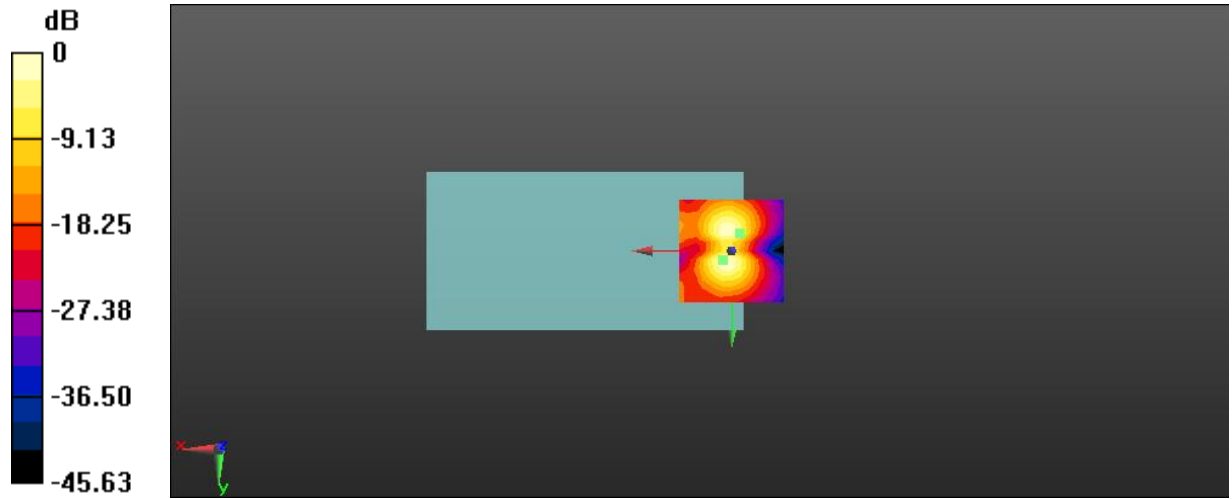
#### Cursor:

ABM1/ABM2 = 29.41 dB

ABM1 comp = -10.89 dBA/m

BWC Factor = 0.16 dB

Location: -4.2, -8.3, 3.7 mm



0 dB = 0.5045 A/m = -5.94 dBA/m

**GSM850 T-coil z (axial)**

Date: 11/05/2017

Communication System: UID 0, GSM (0); Communication System Band: GSM850(824.0-849.0MHz); Frequency: 836.6 MHz; Communication System PAR: 9.191 dB

Medium parameters used:  $\sigma = 0$  S/m,  $\epsilon_r = 1$ ;  $\rho = 0$  kg/m<sup>3</sup>

Phantom section: TCoil Section

Measurement Standard: DASYS (IEEE/IEC/ANSI C63.19-2011)

DASY5 Configuration:

- Probe: AM1DV3 - 3073; ;
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sn1226; Calibrated: 28/09/2016
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASYS2, Version 52.8 (8); SEMCAD X Version 14.6.10 (7331)

**GSM850/General Scans/z (axial) 4.2mm 50 x 50/ABM Signal(x,y,z) (13x13x1):**

Measurement grid: dx=10mm, dy=10mm

Signal Type: Audio File (.wav) 48k\_voice\_1kHz\_1s.wav

Output Gain: 40.41

Measure Window Start: 300ms

Measure Window Length: 1000ms

BWC applied: 0.16 dB

Device Reference Point: 0, 0, -6.3 mm

**Cursor:**

ABM1 comp = 0.03 dBA/m

BWC Factor = 0.16 dB

Location: 0, 0, 3.7 mm

**GSM850/General Scans/z (axial) 4.2mm 50 x 50/ABM SNR(x,y,z) (13x13x1):**

Measurement grid: dx=10mm, dy=10mm

Signal Type: Audio File (.wav) 48k\_voice\_1kHz\_1s.wav

Output Gain: 40.41

Measure Window Start: 300ms

Measure Window Length: 1000ms

BWC applied: 0.16 dB

Device Reference Point: 0, 0, -6.3 mm

**Cursor:**

ABM1/ABM2 = 20.22 dB

ABM1 comp = 0.03 dBA/m

BWC Factor = 0.16 dB

Location: 0, 0, 3.7 mm

**GSM850/General Scans/z (axial) wideband at best S/N/ABM Freq Resp(x,y,z,f)****(1x1x1):** Measurement grid: dx=10mm, dy=10mm

Signal Type: Audio File (.wav) 48k\_voice\_300-3000\_2s.wav

Output Gain: 78.96

Measure Window Start: 300ms

Measure Window Length: 2000ms

BWC applied: 10.80 dB

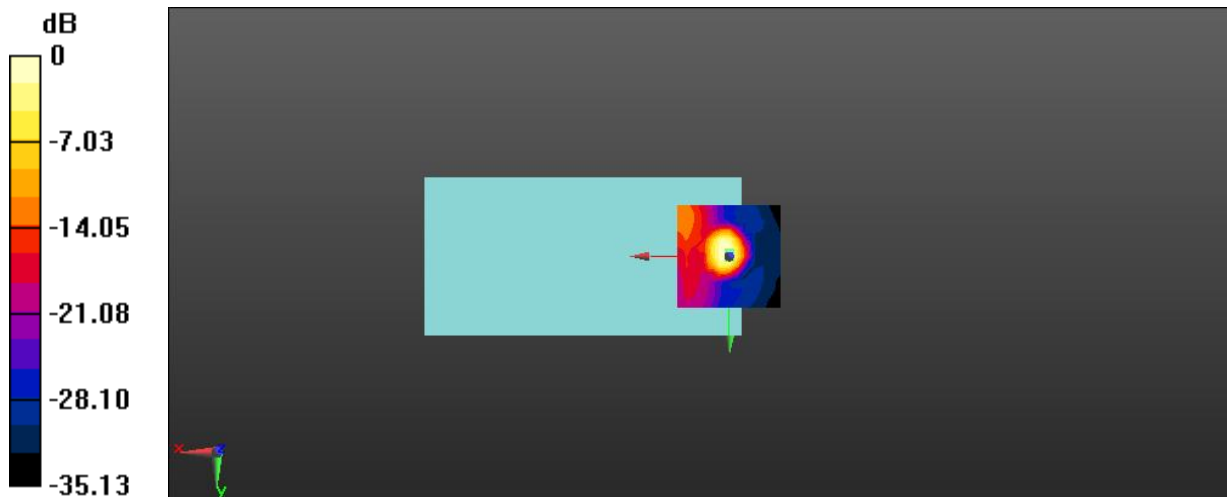
Device Reference Point: 0, 0, -6.3 mm

**Cursor:**

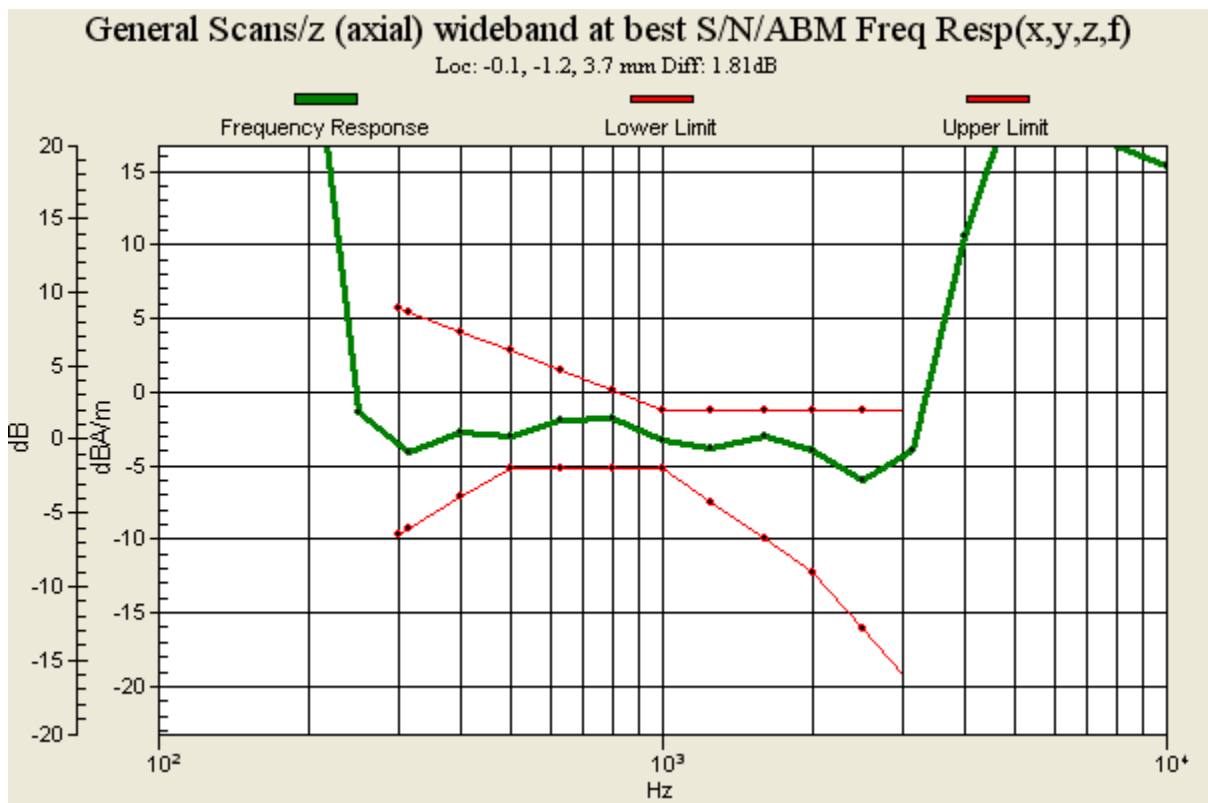
Diff = 1.81 dB

BWC Factor = 10.80 dB

Location: -0.1, -1.2, 3.7 mm



0 dB = 1.004 A/m = 0.03 dBA/m



**GSM1900 T-coil y (transversal)**

Date: 11/05/2017

Communication System: UID 0, GSM (0); Communication System Band: PCS1900(1850.0-1910.0MHz); Frequency: 1880 MHz; Communication System PAR: 9.191 dB

Medium parameters used:  $\sigma = 0$  S/m,  $\epsilon_r = 1$ ;  $\rho = 0$  kg/m<sup>3</sup>

Phantom section: TCoil Section

Measurement Standard: DASYS5 (IEEE/IEC/ANSI C63.19-2011)

DASY5 Configuration:

- Probe: AM1DV3 - 3073; ;
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sn1226; Calibrated: 28/09/2016
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASYS52, Version 52.8 (8); SEMCAD X Version 14.6.10 (7331)

**GSM1900/General Scans/y (transversal) 4.2mm 50 x 50/ABM Signal(x,y,z)****(13x13x1)**: Measurement grid: dx=10mm, dy=10mm

Signal Type: Audio File (.wav) 48k\_voice\_1kHz\_1s.wav

Output Gain: 40.41

Measure Window Start: 300ms

Measure Window Length: 1000ms

BWC applied: 0.16 dB

Device Reference Point: 0, 0, -6.3 mm

**Cursor:**

ABM1 comp = -6.56 dBA/m

BWC Factor = 0.16 dB

Location: 4.2, -8.3, 3.7 mm

**GSM1900/General Scans/y (transversal) 4.2mm 50 x 50/ABM SNR(x,y,z)****(13x13x1)**: Measurement grid: dx=10mm, dy=10mm

Signal Type: Audio File (.wav) 48k\_voice\_1kHz\_1s.wav

Output Gain: 40.41

Measure Window Start: 300ms

Measure Window Length: 1000ms

BWC applied: 0.16 dB

Device Reference Point: 0, 0, -6.3 mm

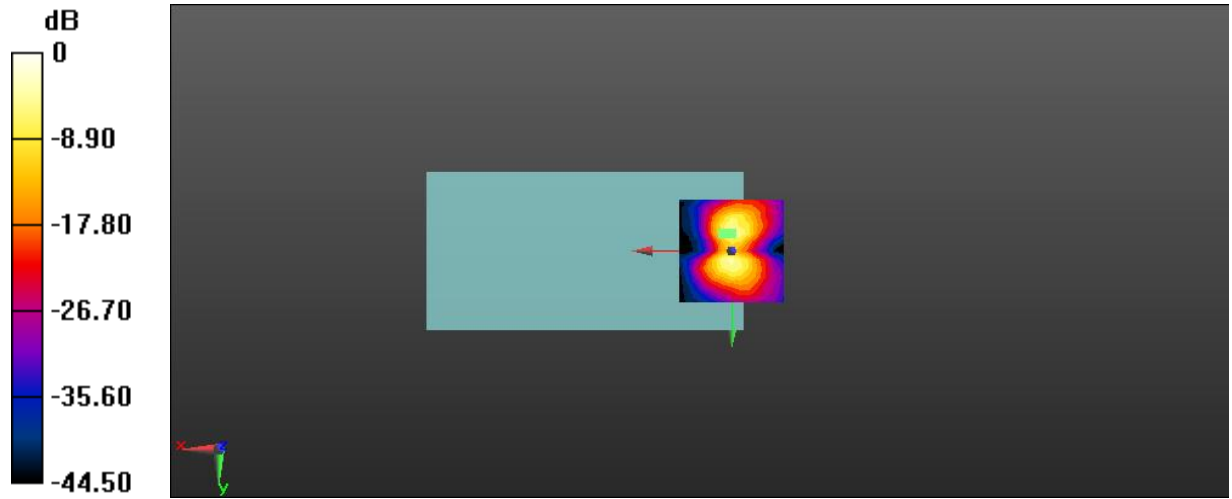
**Cursor:**

ABM1/ABM2 = 32.26 dB

ABM1 comp = -6.87 dBA/m

BWC Factor = 0.16 dB

Location: 0, -8.3, 3.7 mm



0 dB = 0.4699 A/m = -6.56 dBA/m

**GSM1900 T-coil z (axial)**

Date: 11/05/2017

Communication System: UID 0, GSM (0); Communication System Band: PCS1900(1850.0-1910.0MHz); Frequency: 1880 MHz; Communication System PAR: 9.191 dB

Medium parameters used:  $\sigma = 0$  S/m,  $\epsilon_r = 1$ ;  $\rho = 0$  kg/m<sup>3</sup>

Phantom section: TCoil Section

Measurement Standard: DASYS5 (IEEE/IEC/ANSI C63.19-2011)

DASY5 Configuration:

- Probe: AM1DV3 - 3073; ;
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sn1226; Calibrated: 28/09/2016
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASYS2, Version 52.8 (8); SEMCAD X Version 14.6.10 (7331)

**GSM1900/General Scans/z (axial) 4.2mm 50 x 50/ABM Signal(x,y,z) (13x13x1):**

Measurement grid: dx=10mm, dy=10mm

Signal Type: Audio File (.wav) 48k\_voice\_1kHz\_1s.wav

Output Gain: 40.41

Measure Window Start: 300ms

Measure Window Length: 1000ms

BWC applied: 0.16 dB

Device Reference Point: 0, 0, -6.3 mm

**Cursor:**

ABM1 comp = -0.03 dBA/m

BWC Factor = 0.16 dB

Location: 4.2, 0, 3.7 mm

**GSM1900/General Scans/z (axial) 4.2mm 50 x 50/ABM SNR(x,y,z) (13x13x1):**

Measurement grid: dx=10mm, dy=10mm

Signal Type: Audio File (.wav) 48k\_voice\_1kHz\_1s.wav

Output Gain: 40.41

Measure Window Start: 300ms

Measure Window Length: 1000ms

BWC applied: 0.16 dB

Device Reference Point: 0, 0, -6.3 mm

**Cursor:**

ABM1/ABM2 = 23.66 dB

ABM1 comp = -0.19 dBA/m

BWC Factor = 0.16 dB

Location: 0, -4.2, 3.7 mm

**GSM1900/General Scans/z (axial) wideband at best S/N/ABM Freq Resp(x,y,z,f)**

(1x1x1): Measurement grid: dx=10mm, dy=10mm

Signal Type: Audio File (.wav) 48k\_voice\_300-3000\_2s.wav

Output Gain: 78.96

Measure Window Start: 300ms

Measure Window Length: 2000ms

BWC applied: 10.80 dB

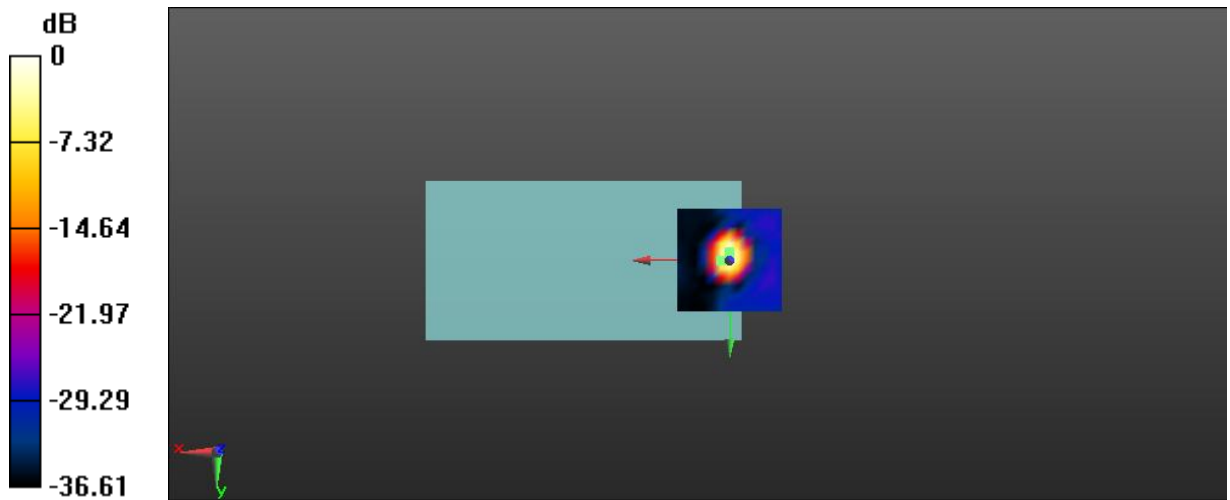
Device Reference Point: 0, 0, -6.3 mm

**Cursor:**

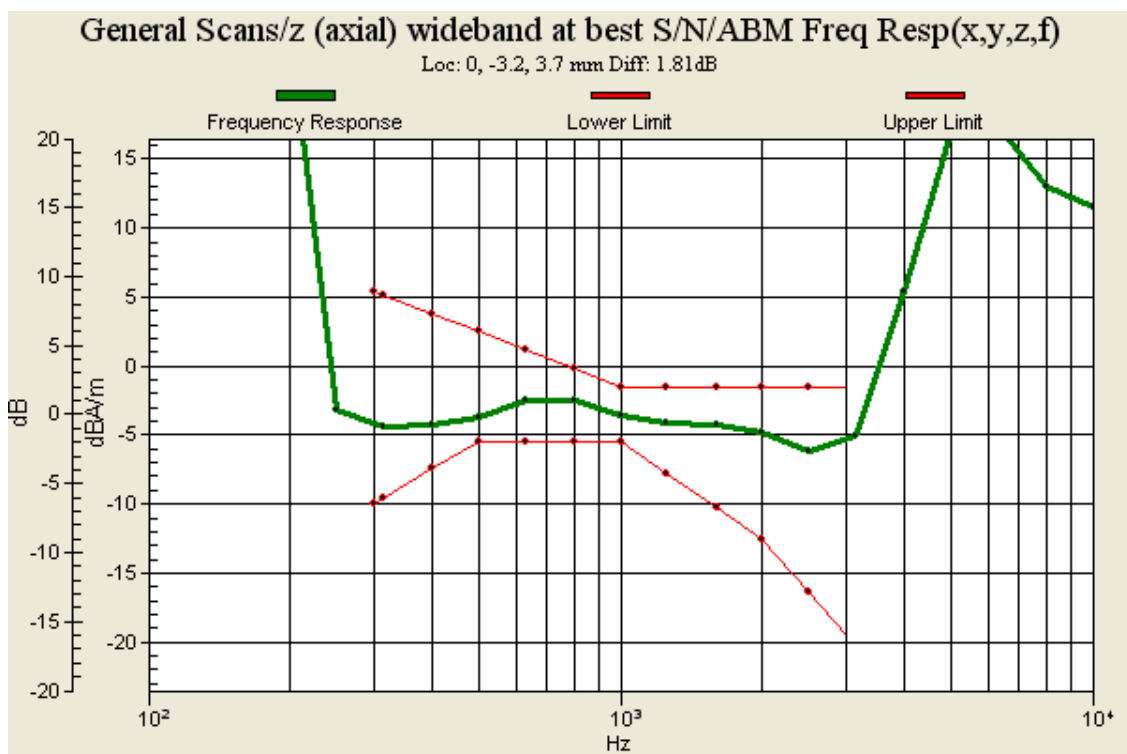
Diff = 1.81 dB

BWC Factor = 10.80 dB

Location: 0, -3.2, 3.7 mm



0 dB = 0.9966 A/m = -0.03 dBA/m





**WCDMA Band II T-coil y (transversal)**

Date: 11/05/2017

Communication System: UID 0, WCDMA (0); Communication System Band: BAND 2;

Frequency: 1880 MHz; Communication System PAR: 0 dB

Medium parameters used:  $\sigma = 0$  S/m,  $\epsilon_r = 1$ ;  $\rho = 0$  kg/m<sup>3</sup>

Phantom section: TCoil Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY5 Configuration:

- Probe: AM1DV3 - 3073; ;
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sn1226; Calibrated: 28/09/2016
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY52, Version 52.8 (8); SEMCAD X Version 14.6.10 (7331)

**WCDMA BAND II/General Scans/y (transversal) 4.2mm 50 x 50/ABM****Signal(x,y,z) (13x13x1):** Measurement grid: dx=10mm, dy=10mm

Signal Type: Audio File (.wav) 48k\_voice\_1kHz\_1s.wav

Output Gain: 40.41

Measure Window Start: 300ms

Measure Window Length: 1000ms

BWC applied: 0.16 dB

Device Reference Point: 0, 0, -6.3 mm

**Cursor:**

ABM1 comp = -6.62 dBA/m

BWC Factor = 0.16 dB

Location: 0, 4.2, 3.7 mm

**WCDMA BAND II/General Scans/y (transversal) 4.2mm 50 x 50/ABM****SNR(x,y,z) (13x13x1):** Measurement grid: dx=10mm, dy=10mm

Signal Type: Audio File (.wav) 48k\_voice\_1kHz\_1s.wav

Output Gain: 40.41

Measure Window Start: 300ms

Measure Window Length: 1000ms

BWC applied: 0.16 dB

Device Reference Point: 0, 0, -6.3 mm

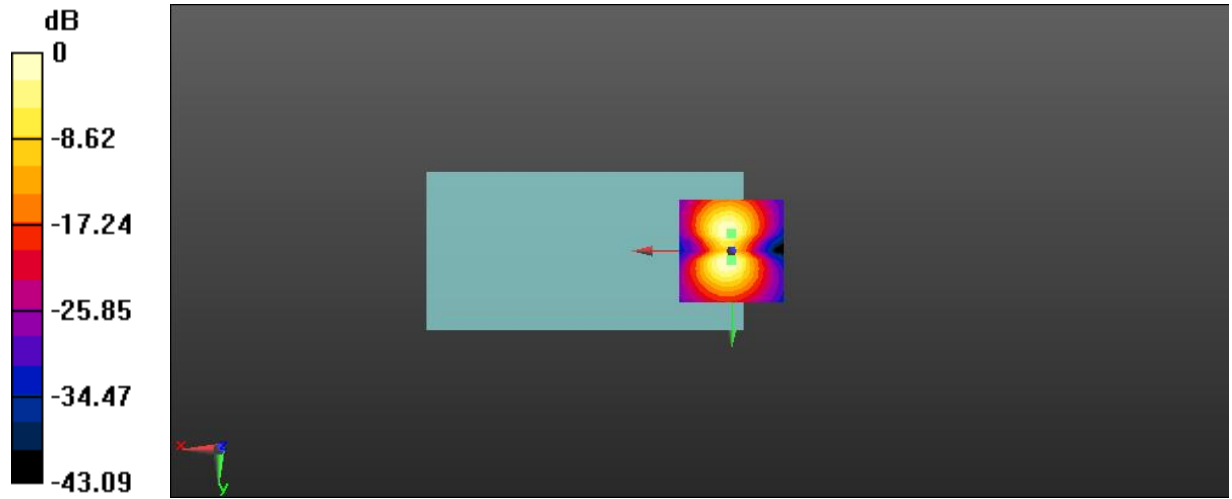
**Cursor:**

ABM1/ABM2 = 34.91 dB

ABM1 comp = -6.63 dBA/m

BWC Factor = 0.16 dB

Location: 0, -8.3, 3.7 mm



0 dB = 0.4667 A/m = -6.62 dBA/m

**WCDMA Band II T-coil z (axial)**

Date: 11/05/2017

Communication System: UID 0, WCDMA (0); Communication System Band: BAND 2;

Frequency: 1880 MHz; Communication System PAR: 0 dB

Medium parameters used:  $\sigma = 0$  S/m,  $\epsilon_r = 1$ ;  $\rho = 0$  kg/m<sup>3</sup>

Phantom section: TCoil Section

Measurement Standard: DASYS5 (IEEE/IEC/ANSI C63.19-2011)

DASY5 Configuration:

- Probe: AM1DV3 - 3073; ;
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sn1226; Calibrated: 28/09/2016
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASYS52, Version 52.8 (8); SEMCAD X Version 14.6.10 (7331)

**WCDMA BAND II/General Scans/z (axial) 4.2mm 50 x 50/ABM Signal(x,y,z)****(13x13x1)**: Measurement grid: dx=10mm, dy=10mm

Signal Type: Audio File (.wav) 48k\_voice\_1kHz\_1s.wav

Output Gain: 40.41

Measure Window Start: 300ms

Measure Window Length: 1000ms

BWC applied: 0.16 dB

Device Reference Point: 0, 0, -6.3 mm

**Cursor:**

ABM1 comp = 0.18 dBA/m

BWC Factor = 0.16 dB

Location: 0, 0, 3.7 mm

**WCDMA BAND II/General Scans/z (axial) 4.2mm 50 x 50/ABM SNR(x,y,z)****(13x13x1)**: Measurement grid: dx=10mm, dy=10mm

Signal Type: Audio File (.wav) 48k\_voice\_1kHz\_1s.wav

Output Gain: 40.41

Measure Window Start: 300ms

Measure Window Length: 1000ms

BWC applied: 0.16 dB

Device Reference Point: 0, 0, -6.3 mm

**Cursor:**

ABM1/ABM2 = 40.50 dB

ABM1 comp = 0.09 dBA/m

BWC Factor = 0.16 dB

Location: 0, -4.2, 3.7 mm

**WCDMA BAND II/General Scans/z (axial) wideband at best S/N/ABM Freq**

**Resp(x,y,z,f) (1x1x1):** Measurement grid: dx=10mm, dy=10mm

Signal Type: Audio File (.wav) 48k\_voice\_300-3000\_2s.wav

Output Gain: 78.96

Measure Window Start: 300ms

Measure Window Length: 2000ms

BWC applied: 10.80 dB

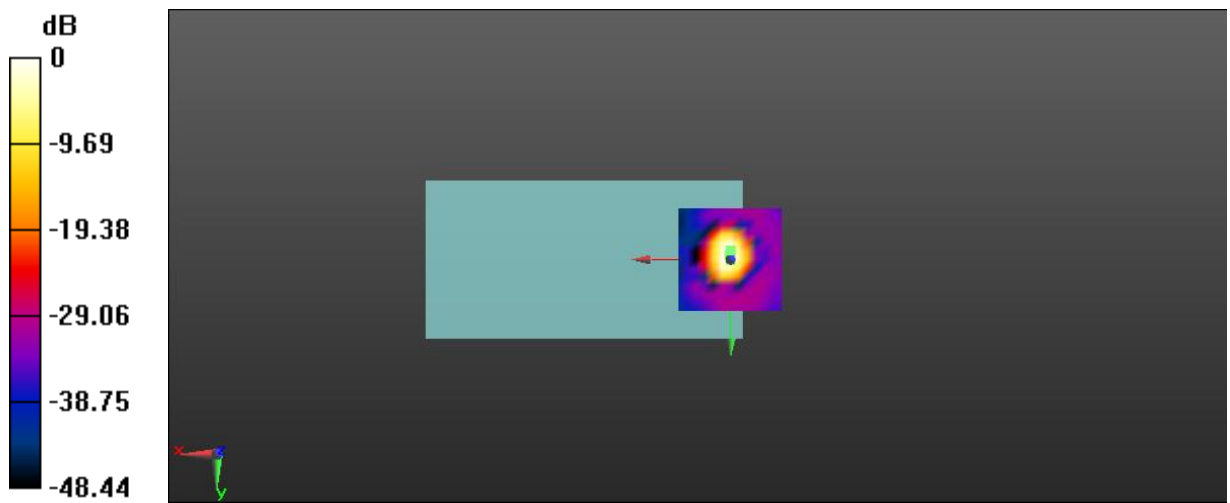
Device Reference Point: 0, 0, -6.3 mm

**Cursor:**

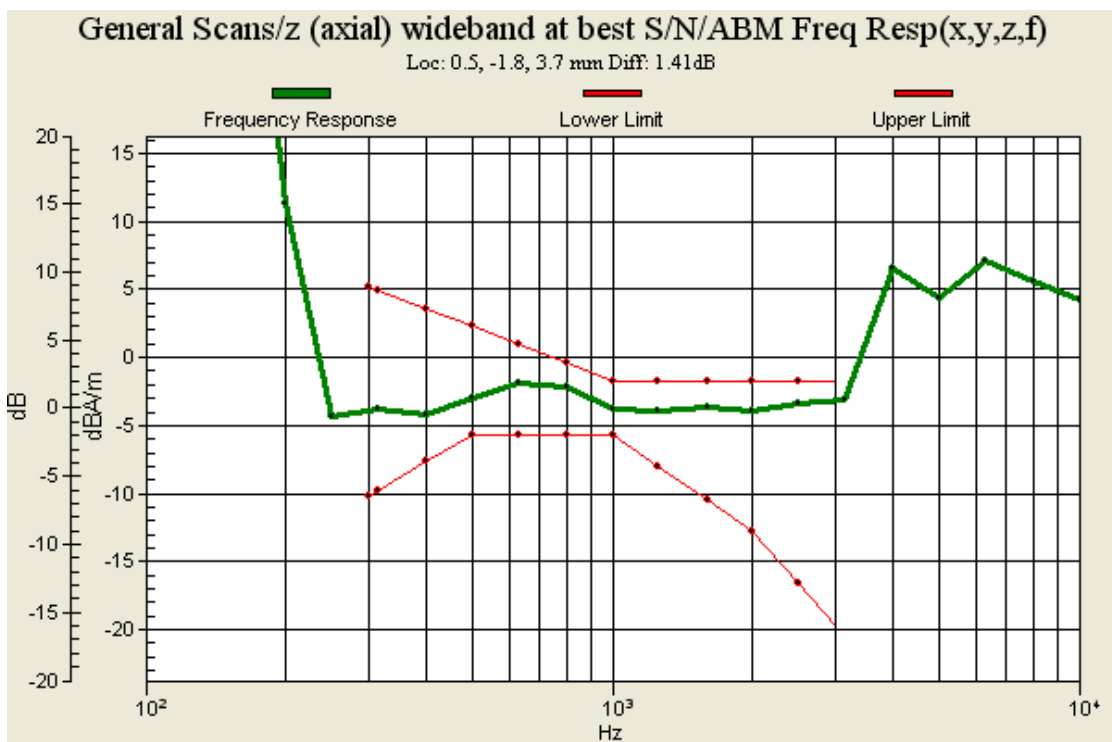
Diff = 1.41 dB

BWC Factor = 10.80 dB

Location: 0.5, -1.8, 3.7 mm



0 dB = 1.021 A/m = 0.18 dBA/m



**WCDMA Band V T-coil y (transversal)**

Date: 11/05/2017

Communication System: UID 0, WCDMA (0); Communication System Band: BAND 5;

Frequency: 836.6 MHz; Communication System PAR: 0 dB

Medium parameters used:  $\sigma = 0$  S/m,  $\epsilon_r = 1$ ;  $\rho = 0$  kg/m<sup>3</sup>

Phantom section: TCoil Section

Measurement Standard: DASYS (IEEE/IEC/ANSI C63.19-2007)

DASY5 Configuration:

- Probe: AM1DV3 - 3073; ;
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sn1226; Calibrated: 28/09/2016
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASYS2, Version 52.8 (8); SEMCAD X Version 14.6.10 (7331)

**WCDMA BAND V/General Scans/y (transversal) 4.2mm 50 x 50/ABM****Signal(x,y,z) (13x13x1):** Measurement grid: dx=10mm, dy=10mm

Signal Type: Audio File (.wav) 48k\_voice\_1kHz\_1s.wav

Output Gain: 40.41

Measure Window Start: 300ms

Measure Window Length: 1000ms

BWC applied: 0.16 dB

Device Reference Point: 0, 0, -6.3 mm

**Cursor:**

ABM1 comp = -6.31 dBA/m

BWC Factor = 0.16 dB

Location: 4.2, -8.3, 3.7 mm

**WCDMA BAND V/General Scans/y (transversal) 4.2mm 50 x 50/ABM****SNR(x,y,z) (13x13x1):** Measurement grid: dx=10mm, dy=10mm

Signal Type: Audio File (.wav) 48k\_voice\_1kHz\_1s.wav

Output Gain: 40.41

Measure Window Start: 300ms

Measure Window Length: 1000ms

BWC applied: 0.16 dB

Device Reference Point: 0, 0, -6.3 mm

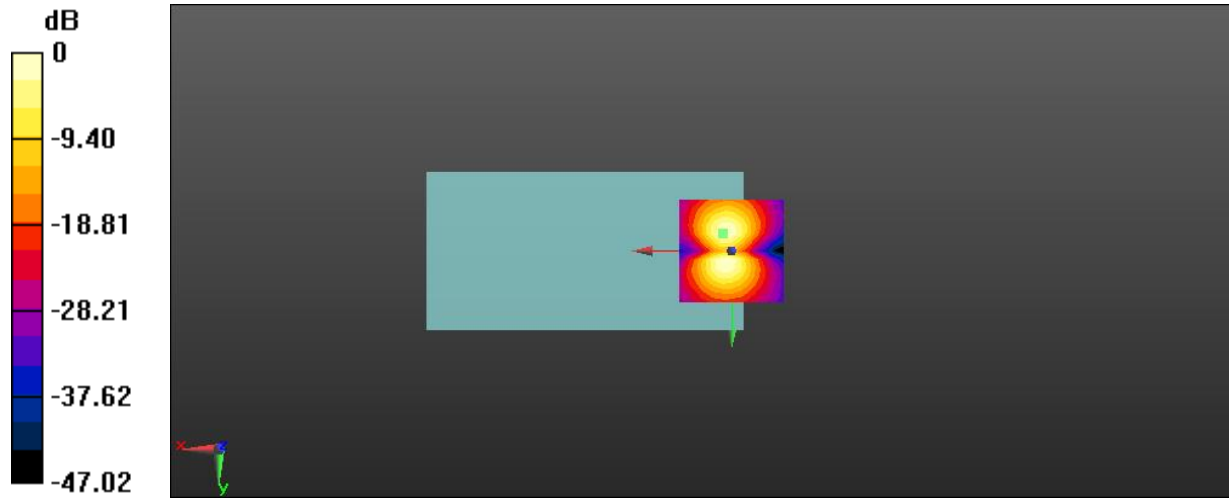
**Cursor:**

ABM1/ABM2 = 34.96 dB

ABM1 comp = -6.31 dBA/m

BWC Factor = 0.16 dB

Location: 4.2, -8.3, 3.7 mm



0 dB = 0.4835 A/m = -6.31 dBA/m

**WCDMA Band V T-coil y (transversal) z (axial)**

Date: 11/05/2017

Communication System: UID 0, WCDMA (0); Communication System Band: BAND 5;

Frequency: 836.6 MHz; Communication System PAR: 0 dB

Medium parameters used:  $\sigma = 0$  S/m,  $\epsilon_r = 1$ ;  $\rho = 0$  kg/m<sup>3</sup>

Phantom section: TCoil Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)

DASY5 Configuration:

- Probe: AM1DV3 - 3073; ;
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sn1226; Calibrated: 28/09/2016
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY52, Version 52.8 (8); SEMCAD X Version 14.6.10 (7331)

**WCDMA BAND V/General Scans/z (axial) 4.2mm 50 x 50/ABM Signal(x,y,z)****(13x13x1)**: Measurement grid: dx=10mm, dy=10mm

Signal Type: Audio File (.wav) 48k\_voice\_1kHz\_1s.wav

Output Gain: 40.41

Measure Window Start: 300ms

Measure Window Length: 1000ms

BWC applied: 0.16 dB

Device Reference Point: 0, 0, -6.3 mm

**Cursor:**

ABM1 comp = -0.01 dBA/m

BWC Factor = 0.16 dB

Location: 4.2, 0, 3.7 mm

**WCDMA BAND V/General Scans/z (axial) 4.2mm 50 x 50/ABM SNR(x,y,z)****(13x13x1)**: Measurement grid: dx=10mm, dy=10mm

Signal Type: Audio File (.wav) 48k\_voice\_1kHz\_1s.wav

Output Gain: 40.41

Measure Window Start: 300ms

Measure Window Length: 1000ms

BWC applied: 0.16 dB

Device Reference Point: 0, 0, -6.3 mm

**Cursor:**

ABM1/ABM2 = 41.94 dB

ABM1 comp = -0.12 dBA/m

BWC Factor = 0.16 dB

Location: 0, 0, 3.7 mm

**WCDMA BAND V/General Scans/z (axial) wideband at best S/N/ABM Freq**

**Resp(x,y,z,f) (1x1x1):** Measurement grid: dx=10mm, dy=10mm

Signal Type: Audio File (.wav) 48k\_voice\_300-3000\_2s.wav

Output Gain: 78.96

Measure Window Start: 300ms

Measure Window Length: 2000ms

BWC applied: 10.80 dB

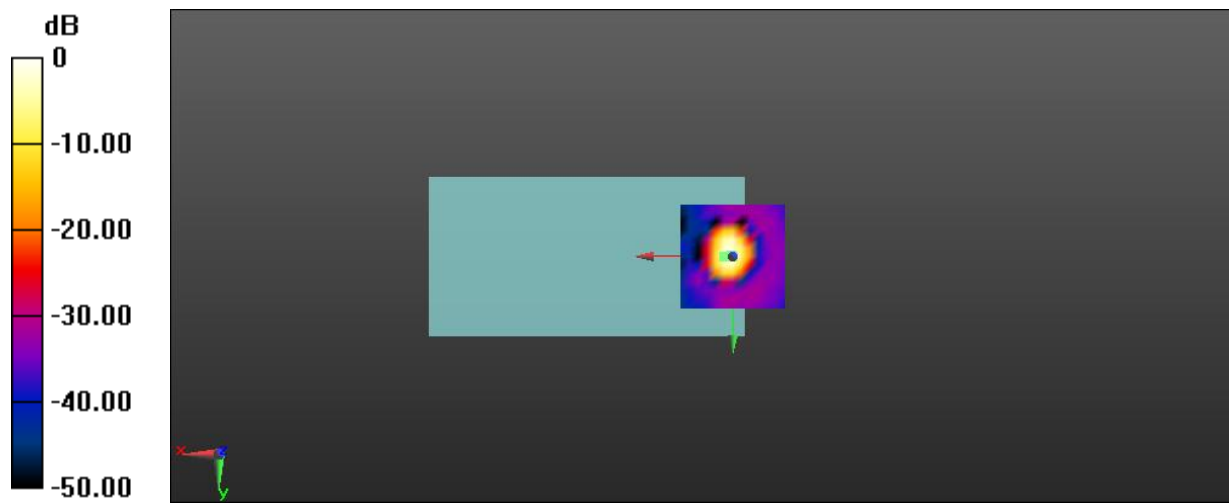
Device Reference Point: 0, 0, -6.3 mm

**Cursor:**

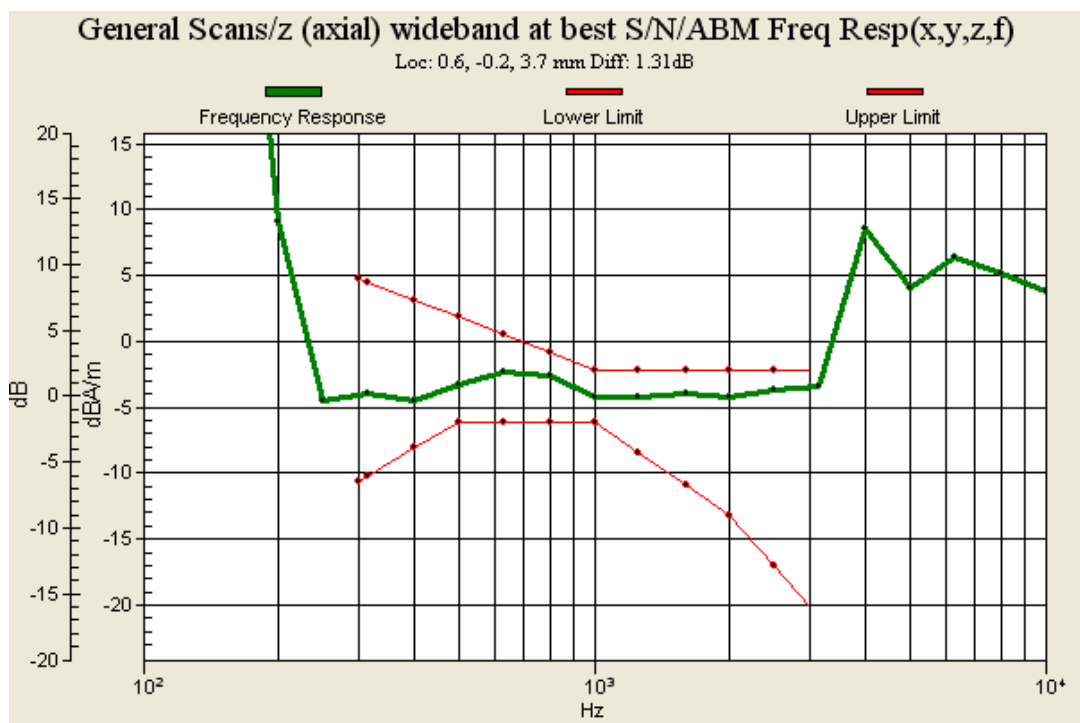
Diff = 1.31 dB

BWC Factor = 10.80 dB

Location: 0.6, -0.2, 3.7 mm



0 dB = 0.9986 A/m = -0.01 dBA/m





# ANNEX H: Probe Calibration Certificate

**Calibration Laboratory of**  
**Schmid & Partner**  
**Engineering AG**  
 Zeughausstrasse 43, 8004 Zurich, Switzerland



**S** Schweizerischer Kalibrierdienst  
**C** Service suisse d'étalonnage  
**S** Servizio svizzero di taratura  
 Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)  
 The Swiss Accreditation Service is one of the signatories to the EA  
 Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 0108**

Client **Tejet (Auden)**

Certificate No: **ER3-2486\_Aug15**

## CALIBRATION CERTIFICATE

Object: **ER3DV6 - SN:2486**

Calibration procedure(s): **QA CAL-02.v8, QA CAL-25.v6**  
 Calibration procedure for E-field probes optimized for close near field evaluations in air

Calibration date: **August 24, 2015**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).  
 The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID	Cal Date (Certificate No.)	Scheduled Calibration
Power meter E4419B	GB41293874	01-Apr-15 (No. 217-02128)	Mar-16
Power sensor E4412A	MY41498087	01-Apr-15 (No. 217-02128)	Mar-16
Reference 3 dB Attenuator	SN: S5054 (3c)	01-Apr-15 (No. 217-02129)	Mar-16
Reference 20 dB Attenuator	SN: S5277 (20x)	01-Apr-15 (No. 217-02132)	Mar-16
Reference 30 dB Attenuator	SN: S5129 (30b)	01-Apr-15 (No. 217-02133)	Mar-16
Reference Probe ER3DV6	SN: 2328	08-Oct-14 (No. ER3-2328_Oct14)	Oct-15
DAE4	SN: 789	16-Mar-15 (No. DAE4-789_Mar15)	Mar-16
Secondary Standards	ID	Check Date (in house)	Scheduled Check
RF generator HP 8648C	US3642U01700	4-Aug-99 (in house check Apr-13)	In house check: Apr-16
Network Analyzer HP 8753E	US37390585	18-Oct-01 (in house check Oct-14)	In house check: Oct-15

	Name	Function	Signature
Calibrated by:	Jeton Kastrati	Laboratory Technician	
Approved by:	Katja Pokovic	Technical Manager	

Issued: August 25, 2015

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

**Calibration Laboratory of**  
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 Engineering AG  
 Zeughausstrasse 43, 8004 Zurich, Switzerland



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**C** Service suisse d'étalonnage  
**S** Servizio svizzero di taratura  
**S** Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)

Accreditation No.: **SCS 0108**

The Swiss Accreditation Service is one of the signatories to the EA  
 Multilateral Agreement for the recognition of calibration certificates

**Glossary:**

NORM <sub>x,y,z</sub>	sensitivity in free space
DCP	diode compression point
CF	crest factor (1/duty_cycle) of the RF signal
A, B, C, D	modulation dependent linearization parameters
Polarization $\phi$	$\phi$ rotation around probe axis
Polarization $\vartheta$	$\vartheta$ rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e., $\vartheta = 0$ is normal to probe axis
Connector Angle	information used in DASY system to align probe sensor X to the robot coordinate system

**Calibration is Performed According to the Following Standards:**

- a) IEEE Std 1309-2005, "IEEE Standard for calibration of electromagnetic field sensors and probes, excluding antennas, from 9 kHz to 40 GHz", December 2005
- b) CTIA Test Plan for Hearing Aid Compatibility, April 2010.

**Methods Applied and Interpretation of Parameters:**

- **NORM<sub>x,y,z</sub>**: Assessed for E-field polarization  $\vartheta = 0$  for XY sensors and  $\vartheta = 90$  for Z sensor ( $f \leq 900$  MHz in TEM-cell;  $f > 1800$  MHz: R22 waveguide).
- **NORM(f)<sub>x,y,z</sub> = NORM<sub>x,y,z</sub> \* frequency\_response** (see Frequency Response Chart).
- **DCP<sub>x,y,z</sub>**: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal (no uncertainty required). DCP does not depend on frequency nor media.
- **PAR**: PAR is the Peak to Average Ratio that is not calibrated but determined based on the signal characteristics
- **A<sub>x,y,z</sub>; B<sub>x,y,z</sub>; C<sub>x,y,z</sub>; D<sub>x,y,z</sub>; VR<sub>x,y,z</sub>; A, B, C, D** are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
- **Spherical isotropy (3D deviation from isotropy)**: in a locally homogeneous field realized using an open waveguide setup.
- **Sensor Offset**: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- **Connector Angle**: The angle is assessed using the information gained by determining the **NORM<sub>x</sub>** (no uncertainty required).

ER3DV6 – SN:2486

August 24, 2015

# Probe ER3DV6

## SN:2486

Manufactured: May 12, 2009  
Calibrated: August 24, 2015

Calibrated for DASY/EASY Systems  
(Note: non-compatible with DASY2 system!)

## DASY/EASY - Parameters of Probe: ER3DV6 - SN:2486

### Basic Calibration Parameters

	Sensor X	Sensor Y	Sensor Z	Unc (k=2)
Norm ( $\mu\text{V}/(\text{V}/\text{m})^2$ )	2.01	1.78	2.02	$\pm 10.1\%$
DCP (mV) <sup>B</sup>	100.5	99.1	99.6	

### Modulation Calibration Parameters

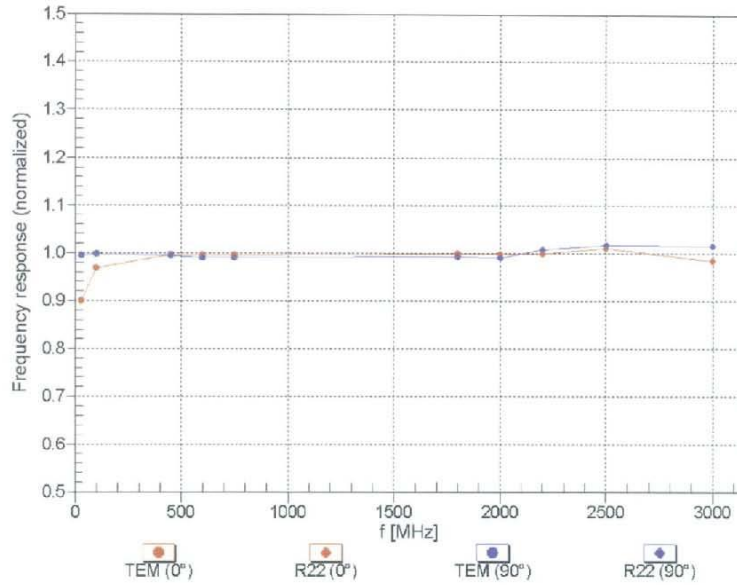
UID	Communication System Name		A dB	B dB $\sqrt{\mu\text{V}}$	C	D dB	VR mV	Unc <sup>E</sup> (k=2)
0	CW	X	0.0	0.0	1.0	0.00	188.9	$\pm 3.5\%$
		Y	0.0	0.0	1.0		205.7	
		Z	0.0	0.0	1.0		210.5	
10011-CAB	UMTS-FDD (WCDMA)	X	3.16	66.4	18.6	2.91	112.1	$\pm 0.7\%$
		Y	3.22	66.3	18.4		123.2	
		Z	3.13	65.8	18.0		124.3	
10012-CAB	IEEE 802.11b WiFi 2.4 GHz (DSSS, 1 Mbps)	X	3.02	69.4	19.5	1.87	114.2	$\pm 0.9\%$
		Y	2.86	68.0	18.7		125.7	
		Z	2.92	68.4	18.7		128.0	
10021-DAB	GSM-FDD (TDMA, GMSK)	X	18.74	99.8	28.9	9.39	109.1	$\pm 1.9\%$
		Y	21.46	99.6	28.4		128.3	
		Z	24.21	99.3	28.2		144.4	
10039-CAB	CDMA2000 (1xRTT, RC1)	X	4.66	66.2	19.0	4.57	108.6	$\pm 0.9\%$
		Y	4.80	66.5	19.1		125.2	
		Z	4.71	66.3	18.8		126.5	
10081-CAB	CDMA2000 (1xRTT, RC3)	X	4.12	67.4	19.6	3.97	145.2	$\pm 0.9\%$
		Y	3.92	65.7	18.6		121.9	
		Z	3.90	65.8	18.5		122.4	

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

<sup>B</sup> Numerical linearization parameter: uncertainty not required.

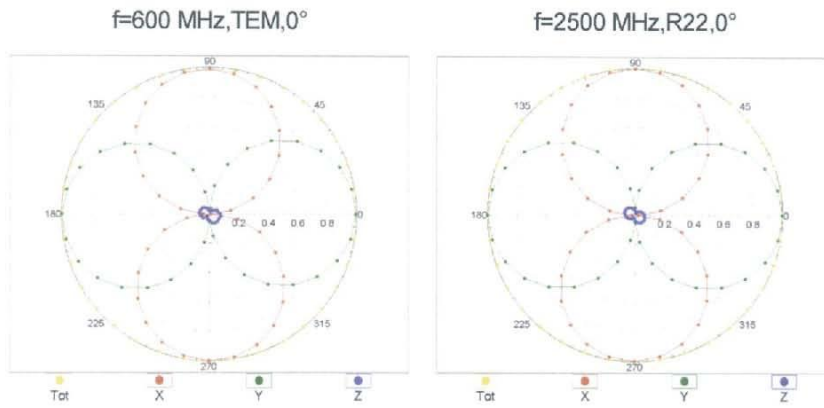
<sup>E</sup> Uncertainty is determined using the max. deviation from linear response applying rectangular distribution and is expressed for the square of the field value.

**Frequency Response of E-Field**  
 (TEM-Cell: ifi110 EXX, Waveguide: R22)

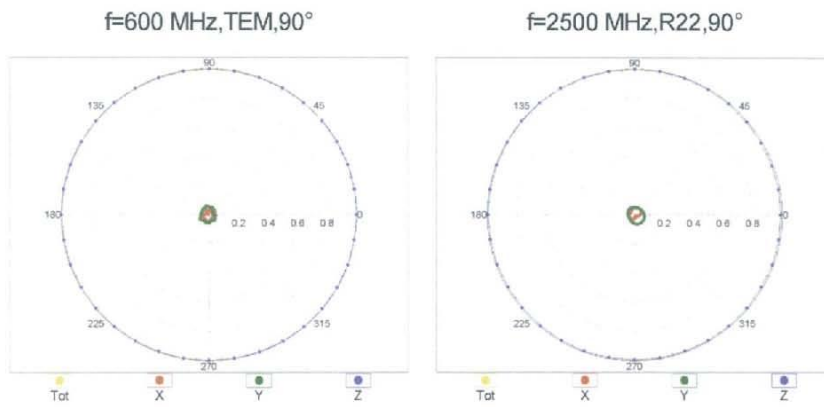


Uncertainty of Frequency Response of E-field:  $\pm 6.3\%$  (k=2)

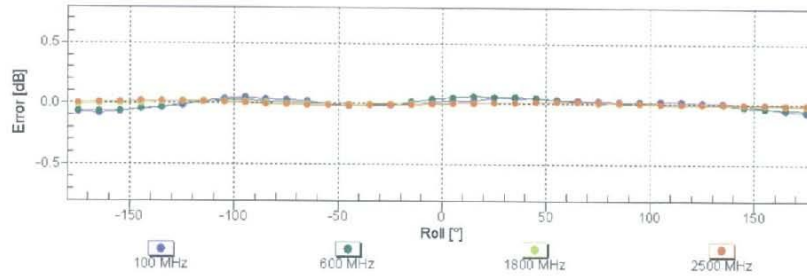
Receiving Pattern ( $\phi$ ),  $\vartheta = 0^\circ$



Receiving Pattern ( $\phi$ ),  $\vartheta = 90^\circ$

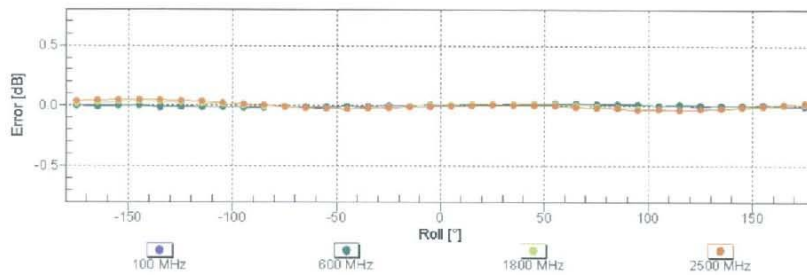


### Receiving Pattern ( $\phi$ ), $\vartheta = 0^\circ$



Uncertainty of Axial Isotropy Assessment:  $\pm 0.5\%$  ( $k=2$ )

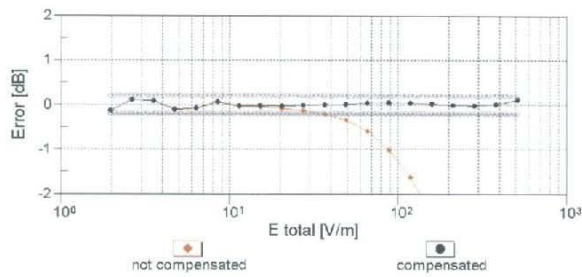
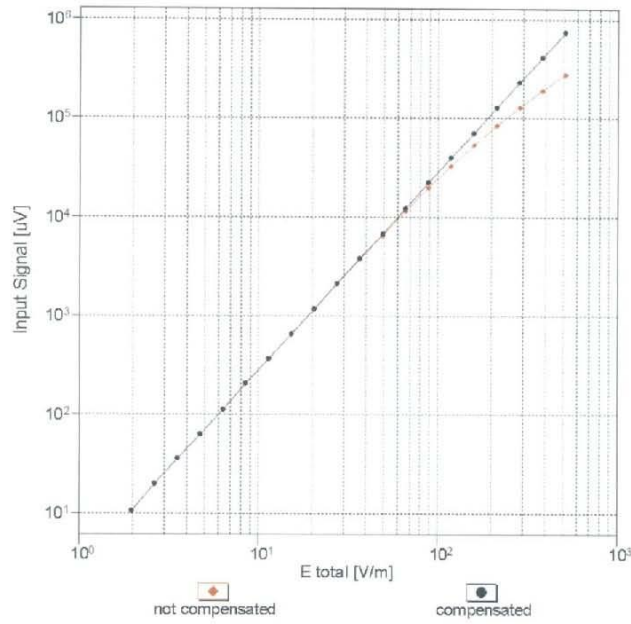
### Receiving Pattern ( $\phi$ ), $\vartheta = 90^\circ$



Uncertainty of Axial Isotropy Assessment:  $\pm 0.5\%$  ( $k=2$ )



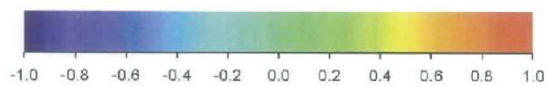
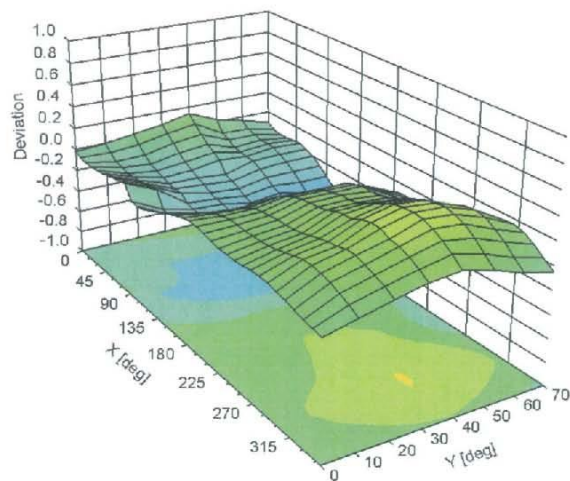
**Dynamic Range f(E-field)**  
(TEM cell , f = 900 MHz)



Uncertainty of Linearity Assessment: ± 0.6% (k=2)



### Deviation from Isotropy in Air Error ( $\phi$ , $\theta$ ), $f = 900$ MHz



Uncertainty of Spherical Isotropy Assessment:  $\pm 2.6\%$  ( $k=2$ )

ER3DV6 – SN:2486

August 24, 2015

### DASY/EASY - Parameters of Probe: ER3DV6 - SN:2486

#### Other Probe Parameters

Sensor Arrangement	Rectangular
Connector Angle (°)	105.2
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disabled
Probe Overall Length	337 mm
Probe Body Diameter	10 mm
Tip Length	10 mm
Tip Diameter	8 mm
Probe Tip to Sensor X Calibration Point	2.5 mm
Probe Tip to Sensor Y Calibration Point	2.5 mm
Probe Tip to Sensor Z Calibration Point	2.5 mm

**Calibration Laboratory of**  
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**Engineering AG**  
 Zeughausstrasse 43, 8004 Zurich, Switzerland



**S** Schweizerischer Kalibrierdienst  
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 Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 0108**

Client **Tejet (Auden)**

Certificate No: **AM1DV3-3073\_Aug15**

**CALIBRATION CERTIFICATE**

Object **AM1DV3 - SN: 3073**

Calibration procedure(s) **QA CAL-24.v4  
 Calibration procedure for AM1D magnetic field probes and TMFS in the  
 audio range**

Calibration date: **August 25, 2015**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).  
 The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Keithley Multimeter Type 2001	SN: 0810278	03-Oct-14 (No:15573)	Oct-15
Reference Probe AM1DV2	SN: 1008	08-Jan-15 (No. AM1D-1008_Jan15)	Jan-16
DAE4	SN: 781	12-Sep-14 (No. DAE4-781_Sep14)	Sep-15
Secondary Standards	ID #	Check Date (in house)	Scheduled Check
AMCC	1050	01-Oct-13 (in house check Oct-13)	Oct-16
AMMI Audio Measuring Instrument	1062	26-Sep-12 (in house check Sep-12)	Sep-15

Calibrated by: **Claudio Leubler** (Name), **Laboratory Technician** (Function), (Signature)

Approved by: **Fin Bomholt** (Name), **Deputy Technical Manager** (Function), (Signature)

Issued: August 26, 2015

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

**[References**

- [1] ANSI-C63.19-2007  
American National Standard for Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.
- [2] ANSI-C63.19-2011  
American National Standard, Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.
- [3] DASY5 manual, Chapter: Hearing Aid Compatibility (HAC) T-Coil Extension

**Description of the AM1D probe**

The AM1D Audio Magnetic Field Probe is a fully shielded magnetic field probe for the frequency range from 100 Hz to 20 kHz. The pickup coil is compliant with the dimensional requirements of [1+2]. The probe includes a symmetric low noise amplifier for the signal available at the shielded 3 pin connector at the side. Power is supplied via the same connector (phantom power supply) and monitored via the LED near the connector. The 7 pin connector at the end of the probe does not carry any signals, but determines the angle of the sensor when mounted on the DAE. The probe supports mechanical detection of the surface.

The single sensor in the probe is arranged in a tilt angle allowing measurement of 3 orthogonal field components when rotating the probe by 120° around its axis. It is aligned with the perpendicular component of the field, if the probe axis is tilted nominally 35.3° above the measurement plane, using the connector rotation and sensor angle stated below.

The probe is fully RF shielded when operated with the matching signal cable (shielded) and allows measurement of audio magnetic fields in the close vicinity of RF emitting wireless devices according to [1+2] without additional shielding.

**Handling of the item**

The probe is manufactured from stainless steel. In order to maintain the performance and calibration of the probe, it must not be opened. The probe is designed for operation in air and shall not be exposed to humidity or liquids. For proper operation of the surface detection and emergency stop functions in a DASY system, the probe must be operated with the special probe cup provided (larger diameter).

**Methods Applied and Interpretation of Parameters**

- *Coordinate System:* The AM1D probe is mounted in the DASY system for operation with a HAC Test Arch phantom with AMCC Helmholtz calibration coil according to [3], with the tip pointing to “southwest” orientation.
- *Functional Test:* The functional test preceding calibration includes test of Noise level RF immunity (1kHz AM modulated signal). The shield of the probe cable must be well connected. Frequency response verification from 100 Hz to 10 kHz.
- *Connector Rotation:* The connector at the end of the probe does not carry any signals and is used for fixation to the DAE only. The probe is operated in the center of the AMCC Helmholtz coil using a 1 kHz magnetic field signal. Its angle is determined from the two minima at nominally +120° and –120° rotation, so the sensor in the tip of the probe is aligned to the vertical plane in z-direction, corresponding to the field maximum in the AMCC Helmholtz calibration coil.
- *Sensor Angle:* The sensor tilting in the vertical plane from the ideal vertical direction is determined from the two minima at nominally +120° and –120°. DASY system uses this angle to align the sensor for radial measurements to the x and y axis in the horizontal plane.

*Sensitivity:* With the probe sensor aligned to the z-field in the AMCC, the output of the probe is compared to the magnetic field in the AMCC at 1 kHz. The field in the AMCC Helmholtz coil is given by the geometry and the current through the coil, which is monitored on the precision shunt resistor of the coil.

**AM1D probe identification and configuration data**

Item	<b>AM1DV3</b> Audio Magnetic 1D Field Probe
Type No	SP AM1 001 BB
Serial No	<b>3073</b>

Overall length	296 mm
Tip diameter	6.0 mm (at the tip)
Sensor offset	3.0 mm (centre of sensor from tip)
Internal Amplifier	20 dB

Manufacturer / Origin	Schmid & Partner Engineering AG, Zürich, Switzerland
Manufacturing date	July 30, 2009
Last calibration date	September 03, 2013

**Calibration data**

Connector rotation angle	(in DASY system)	<b>242.2 °</b>	+/- 3.6 ° (k=2)
Sensor angle	(in DASY system)	<b>0.62 °</b>	+/- 0.5 ° (k=2)
Sensitivity at 1 kHz	(in DASY system)	<b>0.00739 V / (A/m)</b>	+/- 2.2 % (k=2)

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.



# ANNEX I: Dipole CD835V3 Calibration Certificate

**Calibration Laboratory of**  
**Schmid & Partner**  
**Engineering AG**  
 Zeughausstrasse 43, 8004 Zurich, Switzerland



**S** Schweizerischer Kalibrierdienst  
**C** Service suisse d'étalonnage  
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**S** Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)  
 The Swiss Accreditation Service is one of the signatories to the EA  
 Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 0108**

Client **Tejet (Auden)**

Certificate No: **CD835V3-1156\_Aug15**

CALIBRATION CERTIFICATE																																																											
Object	CD835V3 - SN: 1156																																																										
Calibration procedure(s)	QA CAL-20.v6 Calibration procedure for dipoles in air																																																										
Calibration date:	August 20, 2015																																																										
<p>This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).                      The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.</p> <p>All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity &lt; 70%.</p> <p>Calibration Equipment used (M&amp;TE critical for calibration)</p> <table border="1"> <thead> <tr> <th>Primary Standards</th> <th>ID #</th> <th>Cal Date (Certificate No.)</th> <th>Scheduled Calibration</th> </tr> </thead> <tbody> <tr> <td>Power meter EPM-442A</td> <td>GB37480704</td> <td>07-Oct-14 (No. 217-02020)</td> <td>Oct-15</td> </tr> <tr> <td>Power sensor HP 8481A</td> <td>US37292783</td> <td>07-Oct-14 (No. 217-02020)</td> <td>Oct-15</td> </tr> <tr> <td>Power sensor HP 8481A</td> <td>MY41092317</td> <td>07-Oct-14 (No. 217-02021)</td> <td>Oct-15</td> </tr> <tr> <td>Reference 10 dB Attenuator</td> <td>SN: 5047.2 / 06327</td> <td>01-Apr-15 (No. 217-02130)</td> <td>Mar-16</td> </tr> <tr> <td>Probe ER3DV6</td> <td>SN: 2336</td> <td>31-Dec-14 (No. ER3-2336_Dec14)</td> <td>Dec-15</td> </tr> <tr> <td>Probe H3DV6</td> <td>SN: 6065</td> <td>31-Dec-14 (No. H3-6065_Dec14)</td> <td>Dec-15</td> </tr> <tr> <td>DAE4</td> <td>SN: 781</td> <td>12-Sep-14 (No. DAE4-781_Sep14)</td> <td>Sep-15</td> </tr> </tbody> </table> <table border="1"> <thead> <tr> <th>Secondary Standards</th> <th>ID #</th> <th>Check Date (in house)</th> <th>Scheduled Check</th> </tr> </thead> <tbody> <tr> <td>Power meter Agilent 4419B</td> <td>SN: GB42420191</td> <td>09-Oct-09 (in house check Sep-14)</td> <td>In house check: Sep-16</td> </tr> <tr> <td>Power sensor HP E4412A</td> <td>SN: US38485102</td> <td>05-Jan-10 (in house check Sep-14)</td> <td>In house check: Sep-16</td> </tr> <tr> <td>Power sensor HP 8482A</td> <td>SN: US37295597</td> <td>09-Oct-09 (in house check Sep-14)</td> <td>In house check: Sep-16</td> </tr> <tr> <td>Network Analyzer HP 8753E</td> <td>US37390585</td> <td>18-Oct-01 (in house check Oct-14)</td> <td>In house check: Oct-15</td> </tr> <tr> <td>RF generator R&amp;S SMT-06</td> <td>SN: 832283/011</td> <td>27-Aug-12 (in house check Oct-13)</td> <td>In house check: Oct-16</td> </tr> </tbody> </table>				Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration	Power meter EPM-442A	GB37480704	07-Oct-14 (No. 217-02020)	Oct-15	Power sensor HP 8481A	US37292783	07-Oct-14 (No. 217-02020)	Oct-15	Power sensor HP 8481A	MY41092317	07-Oct-14 (No. 217-02021)	Oct-15	Reference 10 dB Attenuator	SN: 5047.2 / 06327	01-Apr-15 (No. 217-02130)	Mar-16	Probe ER3DV6	SN: 2336	31-Dec-14 (No. ER3-2336_Dec14)	Dec-15	Probe H3DV6	SN: 6065	31-Dec-14 (No. H3-6065_Dec14)	Dec-15	DAE4	SN: 781	12-Sep-14 (No. DAE4-781_Sep14)	Sep-15	Secondary Standards	ID #	Check Date (in house)	Scheduled Check	Power meter Agilent 4419B	SN: GB42420191	09-Oct-09 (in house check Sep-14)	In house check: Sep-16	Power sensor HP E4412A	SN: US38485102	05-Jan-10 (in house check Sep-14)	In house check: Sep-16	Power sensor HP 8482A	SN: US37295597	09-Oct-09 (in house check Sep-14)	In house check: Sep-16	Network Analyzer HP 8753E	US37390585	18-Oct-01 (in house check Oct-14)	In house check: Oct-15	RF generator R&S SMT-06	SN: 832283/011	27-Aug-12 (in house check Oct-13)	In house check: Oct-16
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Accreditation No.: SCS 0108

**References**

- [1] ANSI-C63.19-2011  
 American National Standard, Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.

**Methods Applied and Interpretation of Parameters:**

- *Coordinate System:* y-axis is in the direction of the dipole arms. z-axis is from the basis of the antenna (mounted on the table) towards its feed point between the two dipole arms. x-axis is normal to the other axes. In coincidence with the standards [1], the measurement planes (probe sensor center) are selected to be at a distance of 15 mm above the top metal edge of the dipole arms.
- *Measurement Conditions:* Further details are available from the hardcopies at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated. The forward power to the dipole connector is set with a calibrated power meter connected and monitored with an auxiliary power meter connected to a directional coupler. While the dipole under test is connected, the forward power is adjusted to the same level.
- *Antenna Positioning:* The dipole is mounted on a HAC Test Arch phantom using the matching dipole positioner with the arms horizontal and the feeding cable coming from the floor. The measurements are performed in a shielded room with absorbers around the setup to reduce the reflections. It is verified before the mounting of the dipole under the Test Arch phantom, that its arms are perfectly in a line. It is installed on the HAC dipole positioner with its arms parallel below the dielectric reference wire and able to move elastically in vertical direction without changing its relative position to the top center of the Test Arch phantom. The vertical distance to the probe is adjusted after dipole mounting with a DASY5 Surface Check job. Before the measurement, the distance between phantom surface and probe tip is verified. The proper measurement distance is selected by choosing the matching section of the HAC Test Arch phantom with the proper device reference point (upper surface of the dipole) and the matching grid reference point (tip of the probe) considering the probe sensor offset. The vertical distance to the probe is essential for the accuracy.
- *Feed Point Impedance and Return Loss:* These parameters are measured using a HP 8753E Vector Network Analyzer. The impedance is specified at the SMA connector of the dipole. The influence of reflections was eliminated by applying the averaging function while moving the dipole in the air, at least 70cm away from any obstacles.
- *E-field distribution:* E field is measured in the x-y-plane with an isotropic ER3D-field probe with 100 mW forward power to the antenna feed point. In accordance with [1], the scan area is 20mm wide, its length exceeds the dipole arm length (180 or 90mm). The sensor center is 15 mm (in z) above the metal top of the dipole arms. Two 3D maxima are available near the end of the dipole arms. Assuming the dipole arms are perfectly in one line, the average of these two maxima (in subgrid 2 and subgrid 8) is determined to compensate for any non-parallelity to the measurement plane as well as the sensor displacement. The E-field value stated as calibration value represents the maximum of the interpolated 3D-E-field, in the plane above the dipole surface.

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

**Measurement Conditions**

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V52.8.8
Phantom	HAC Test Arch	
Distance Dipole Top - Probe Center	15 mm	
Scan resolution	dx, dy = 5 mm	
Frequency	835 MHz ± 1 MHz	
Input power drift	< 0.05 dB	

**Maximum Field values at 835 MHz**

E-field 15 mm above dipole surface	condition	Interpolated maximum
Maximum measured above high end	100 mW input power	108.0 V/m = 40.67 dBV/m
Maximum measured above low end	100 mW input power	106.2 V/m = 40.52 dBV/m
Averaged maximum above arm	100 mW input power	<b>107.1 V/m ± 12.8 % (k=2)</b>

**Appendix (Additional assessments outside the scope of SCS 0108)**

**Antenna Parameters**

Frequency	Return Loss	Impedance
800 MHz	17.1 dB	43.6 Ω - 11.5 jΩ
835 MHz	25.5 dB	49.9 Ω + 5.3 jΩ
900 MHz	15.5 dB	58.4 Ω - 16.3 jΩ
950 MHz	20.9 dB	41.7 Ω + 0.1 jΩ
960 MHz	19.4 dB	45.1 Ω + 9.0 jΩ

**3.2 Antenna Design and Handling**

The calibration dipole has a symmetric geometry with a built-in two stub matching network, which leads to the enhanced bandwidth.

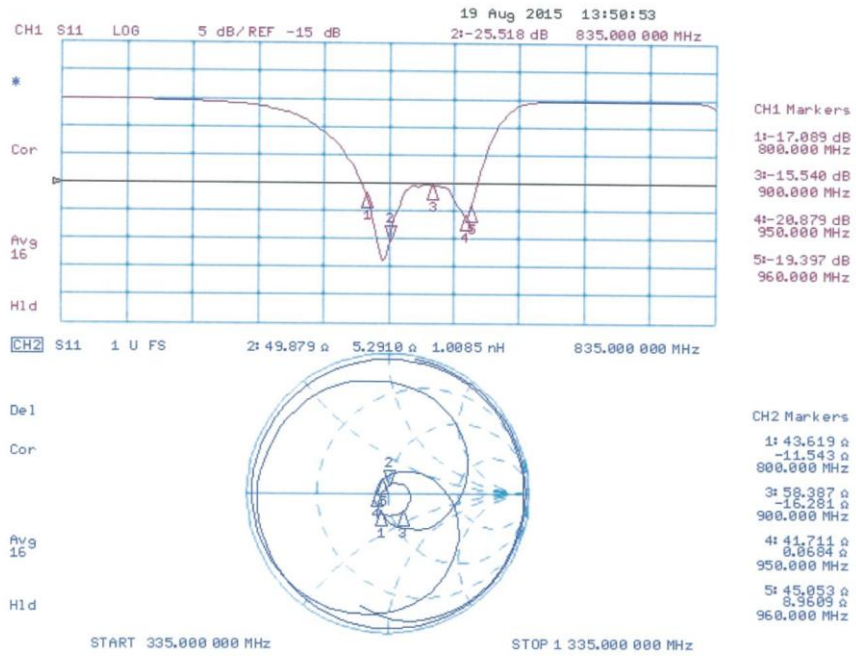
The dipole is built of standard semirigid coaxial cable. The internal matching line is open ended. The antenna is therefore open for DC signals.

Do not apply force to dipole arms, as they are liable to bend. The soldered connections near the feedpoint may be damaged. After excessive mechanical stress or overheating, check the impedance characteristics to ensure that the internal matching network is not affected.

After long term use with 40W radiated power, only a slight warming of the dipole near the feedpoint can be measured.



Impedance Measurement Plot



**DASY5 E-field Result**

Date: 20.08.2015

Test Laboratory: SPEAG Lab2

**DUT: HAC-Dipole 835 MHz; Type: CD835V3; Serial: CD835V3 - SN: 1156**

Communication System: UID 0 - CW ; Frequency: 835 MHz  
 Medium parameters used:  $\sigma = 0$  S/m,  $\epsilon_r = 1$ ;  $\rho = 1000$  kg/m<sup>3</sup>  
 Phantom section: RF Section  
 Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY52 Configuration:

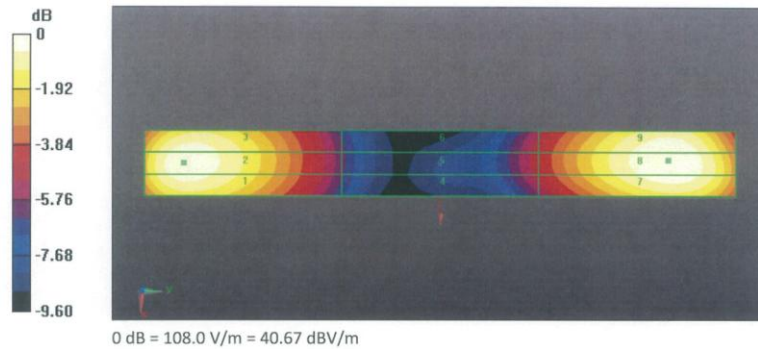
- Probe: ER3DV6 - SN2336; ConvF(1, 1, 1); Calibrated: 31.12.2014;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 12.09.2014
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- DASY52 52.8.8(1222); SEMCAD X 14.6.10(7331)

**Dipole E-Field measurement @ 835MHz/E-Scan - 835MHz d=15mm/Hearing Aid Compatibility Test (41x361x1):**

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm  
 Device Reference Point: 0, 0, -6.3 mm  
 Reference Value = 124.8 V/m; Power Drift = 0.04 dB  
 Applied MIF = 0.00 dB  
 RF audio interference level = 40.67 dBV/m  
**Emission category: M3**

MIF scaled E-field

Grid 1 M3 40.32 dBV/m	Grid 2 M3 40.52 dBV/m	Grid 3 M3 40.39 dBV/m
Grid 4 M4 35.89 dBV/m	Grid 5 M4 36.13 dBV/m	Grid 6 M4 36.08 dBV/m
Grid 7 M3 40.44 dBV/m	Grid 8 M3 40.67 dBV/m	Grid 9 M3 40.58 dBV/m



# ANNEX J: Dipole CD1880V3 Calibration Certificate

**Calibration Laboratory of  
Schmid & Partner  
Engineering AG**  
Zeughausstrasse 43, 8004 Zurich, Switzerland



**S** Schweizerischer Kalibrierdienst  
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Accreditation No.: **SCS 0108**

Client **Tejet (Auden)**

Certificate No: **CD1880V3-1140\_Aug15**

CALIBRATION CERTIFICATE																																																											
Object	CD1880V3 - SN: 1140																																																										
Calibration procedure(s)	QA CAL-20.v6 Calibration procedure for dipoles in air																																																										
Calibration date:	August 20, 2015																																																										
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**References**

- [1] ANSI-C63.19-2011  
American National Standard, Methods of Measurement of Compatibility between Wireless Communications  
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**Methods Applied and Interpretation of Parameters:**

- *Coordinate System:* y-axis is in the direction of the dipole arms. z-axis is from the basis of the antenna (mounted on the table) towards its feed point between the two dipole arms. x-axis is normal to the other axes. In coincidence with the standards [1], the measurement planes (probe sensor center) are selected to be at a distance of 15 mm above the top metal edge of the dipole arms.
- *Measurement Conditions:* Further details are available from the hardcopies at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated. The forward power to the dipole connector is set with a calibrated power meter connected and monitored with an auxiliary power meter connected to a directional coupler. While the dipole under test is connected, the forward power is adjusted to the same level.
- *Antenna Positioning:* The dipole is mounted on a HAC Test Arch phantom using the matching dipole positioner with the arms horizontal and the feeding cable coming from the floor. The measurements are performed in a shielded room with absorbers around the setup to reduce the reflections. It is verified before the mounting of the dipole under the Test Arch phantom, that its arms are perfectly in a line. It is installed on the HAC dipole positioner with its arms parallel below the dielectric reference wire and able to move elastically in vertical direction without changing its relative position to the top center of the Test Arch phantom. The vertical distance to the probe is adjusted after dipole mounting with a DASY5 Surface Check job. Before the measurement, the distance between phantom surface and probe tip is verified. The proper measurement distance is selected by choosing the matching section of the HAC Test Arch phantom with the proper device reference point (upper surface of the dipole) and the matching grid reference point (tip of the probe) considering the probe sensor offset. The vertical distance to the probe is essential for the accuracy.
- *Feed Point Impedance and Return Loss:* These parameters are measured using a HP 8753E Vector Network Analyzer. The impedance is specified at the SMA connector of the dipole. The influence of reflections was eliminated by applying the averaging function while moving the dipole in the air, at least 70cm away from any obstacles.
- *E-field distribution:* E field is measured in the x-y-plane with an isotropic ER3D-field probe with 100 mW forward power to the antenna feed point. In accordance with [1], the scan area is 20mm wide, its length exceeds the dipole arm length (180 or 90mm). The sensor center is 15 mm (in z) above the metal top of the dipole arms. Two 3D maxima are available near the end of the dipole arms. Assuming the dipole arms are perfectly in one line, the average of these two maxima (in subgrid 2 and subgrid 8) is determined to compensate for any non-parallelity to the measurement plane as well as the sensor displacement. The E-field value stated as calibration value represents the maximum of the interpolated 3D-E-field, in the plane above the dipole surface.

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor  $k=2$ , which for a normal distribution corresponds to a coverage probability of approximately 95%.



**Measurement Conditions**

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V52.8.8
Phantom	HAC Test Arch	
Distance Dipole Top - Probe Center	15 mm	
Scan resolution	dx, dy = 5 mm	
Frequency	1880 MHz ± 1 MHz	
Input power drift	< 0.05 dB	

**Maximum Field values at 1880 MHz**

E-field 15 mm above dipole surface	condition	Interpolated maximum
Maximum measured above high end	100 mW input power	90.2 V/m = 39.11 dBV/m
Maximum measured above low end	100 mW input power	87.4 V/m = 38.83 dBV/m
Averaged maximum above arm	100 mW input power	<b>88.8 V/m ± 12.8 % (k=2)</b>

**Appendix (Additional assessments outside the scope of SCS 0108)**

**Antenna Parameters**

Frequency	Return Loss	Impedance
1730 MHz	24.0 dB	49.5 Ω + 6.3 jΩ
1880 MHz	20.3 dB	48.9 Ω + 9.5 jΩ
1900 MHz	20.8 dB	52.3 Ω + 9.0 jΩ
1950 MHz	27.0 dB	54.6 Ω + 0.9 jΩ
2000 MHz	21.9 dB	42.6 Ω - 0.7 jΩ

**3.2 Antenna Design and Handling**

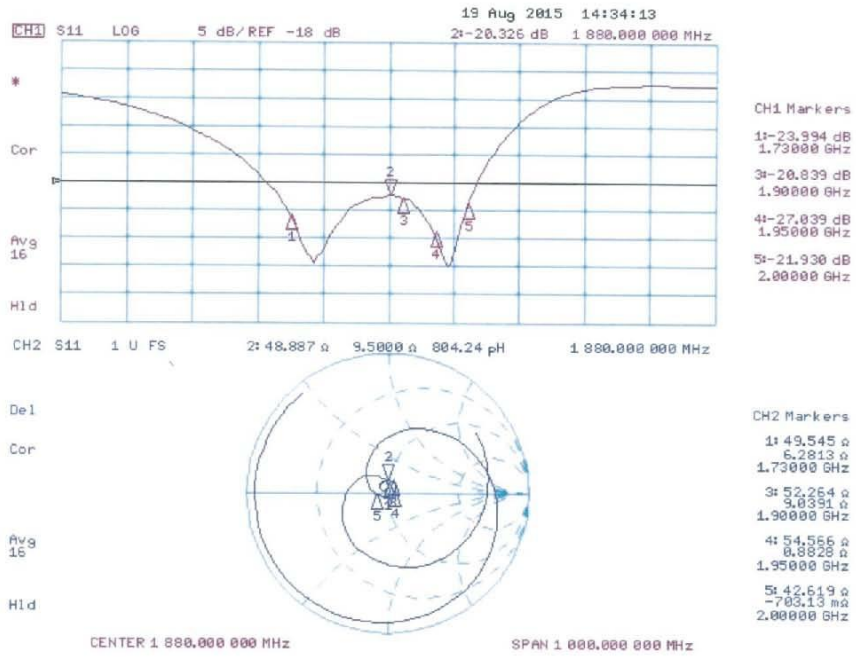
The calibration dipole has a symmetric geometry with a built-in two stub matching network, which leads to the enhanced bandwidth.

The dipole is built of standard semirigid coaxial cable. The internal matching line is open ended. The antenna is therefore open for DC signals.

Do not apply force to dipole arms, as they are liable to bend. The soldered connections near the feedpoint may be damaged. After excessive mechanical stress or overheating, check the impedance characteristics to ensure that the internal matching network is not affected.

After long term use with 40W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

Impedance Measurement Plot



**DASY5 E-field Result**

Date: 20.08.2015

Test Laboratory: SPEAG Lab2

**DUT: HAC Dipole 1880 MHz; Type: CD1880V3; Serial: CD1880V3 - SN: 1140**

Communication System: UID 0 - CW ; Frequency: 1880 MHz  
 Medium parameters used:  $\sigma = 0$  S/m,  $\epsilon_r = 1$ ;  $\rho = 1000$  kg/m<sup>3</sup>  
 Phantom section: RF Section  
 Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY52 Configuration:

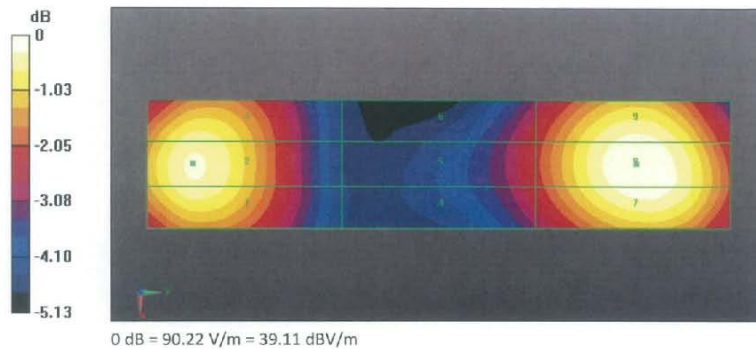
- Probe: ER3DV6 - SN2336; ConvF(1, 1, 1); Calibrated: 31.12.2014;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 12.09.2014
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- DASY52 52.8.8(1222); SEMCAD X 14.6.10(7331)

**Dipole E-Field measurement @ 1880MHz/E-Scan - 1880MHz d=15mm/Hearing Aid Compatibility Test (41x181x1):**

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm  
 Device Reference Point: 0, 0, -6.3 mm  
 Reference Value = 138.0 V/m; Power Drift = 0.00 dB  
 Applied MIF = 0.00 dB  
 RF audio interference level = 39.11 dBV/m  
**Emission category: M2**

MIF scaled E-field

Grid 1 M2 38.69 dBV/m	Grid 2 M2 38.83 dBV/m	Grid 3 M2 38.64 dBV/m
Grid 4 M2 36.81 dBV/m	Grid 5 M2 36.93 dBV/m	Grid 6 M2 36.83 dBV/m
Grid 7 M2 38.99 dBV/m	Grid 8 M2 39.11 dBV/m	Grid 9 M2 38.91 dBV/m



**DASY5 E-field Result**

Date: 30.08.2012

Test Laboratory: SPEAG Lab2

DUT: HAC Dipole 1880 MHz; Type: CD1880V3; Serial: CD1880V3 - SN: 1140

Communication System: CW; Frequency: 1880 MHz  
 Medium parameters used:  $\sigma = 0$  mho/m,  $\epsilon_r = 1$ ;  $\rho = 1000$  kg/m<sup>3</sup>  
 Phantom section: RF Section  
 Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)

DASY52 Configuration:

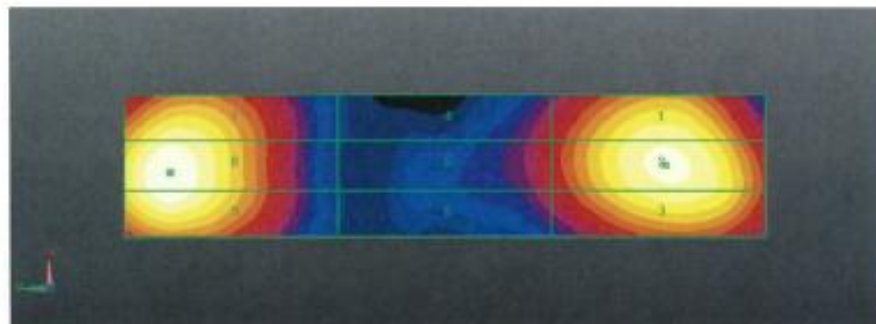
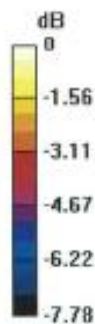
- Probe: ER3DV6 - 5N2336; ConvF[1, 1, 1]; Calibrated: 29.12.2011
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 5n781; Calibrated: 29.05.2012
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- DASY52 52.8.2(969); SEMCAD X 14.6.4(4989)

**Dipole E-Field measurement @ 1880MHz/E-Scan - 1880MHz d=10mm/Hearing Aid Compatibility Test (41x181x1):**

Measurement grid: dx=5mm, dy=5mm  
 Device Reference Point: 0, 0, -6.3 mm  
 Reference Value = 160.3 V/m; Power Drift = -0.04 dB  
 PMR not calibrated. PMF = 1.000 is applied.  
 E-field emissions = 140.8 V/m  
 Near-field category: M2 (AWF 0 dB)

PMF scaled E-field

Grid 1 M2	Grid 2 M2	Grid 3 M2
131.7 V/m	135.2 V/m	130.8 V/m
Grid 4 M3	Grid 5 M3	Grid 6 M3
92.26 V/m	94.13 V/m	89.61 V/m
Grid 7 M2	Grid 8 M2	Grid 9 M2
131.7 V/m	140.8 V/m	138.5 V/m



0 dB = 140.8V/m = 42.97 dB V/m



## ANNEX K: TMFS Calibration Certificate

**Calibration Laboratory of  
Schmid & Partner  
Engineering AG**  
Zeughausstrasse 43, 8004 Zurich, Switzerland



**S** Schweizerischer Kalibrierdienst  
**S** Service suisse d'étalonnage  
**C** Servizio svizzero di taratura  
**S** Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)  
The Swiss Accreditation Service is one of the signatories to the EA  
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

Client **Tejet (Auden)**

Certificate No: **TMFS\_1046\_Feb13**

CALIBRATION CERTIFICATE			
Object / Identification	TMFS – SN: 1046		
Calibration procedure(s)	QA CAL-24.v3 Calibration procedure for AM1D magnetic field probes and TMFS in the audio range		
Calibration date	February 20, 2013		
<p>This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The calibrations have been conducted in the R&amp;D laboratory facility: environment temperature (22 ± 3)°C and humidity &lt; 70%.</p> <p>Calibration Equipment used (M&amp;TE critical for calibration)</p>			
Primary Standards	ID #	Cal Date (Calibrated by, Certificate No.)	Scheduled Calibration
Keithley Multimeter Type 2001	SN: 0810278	02-Oct-12 (No.12728)	Oct-13
Secondary Standards	ID #	Cal / Check Date	Scheduled Calibration Check
AMCC	1050	12-Oct-11 (in house check Oct-11)	Oct-13
Reference Probe AM1DV2	SN: 1008	10-Jan-13 (No. AM1D-1008_Jan13)	Jan-14
AMMI Audio Measuring Instrument	1062	20-Sep-12 (in house check Sep-12)	Sep-14
Agilent WF Generator 33120A	MY40005266	12-Oct-11 (in house check Oct-11)	Oct-13
Keithley Multimeter Type 2001	SN: 0961047	22-Oct-12 ( in house check Oct-12)	Oct-13
Calibrated by:	Name Claudio Leubler	Function Laboratory Technician	Signature 
Approved by:	Katja Pokovic	Technical Manager	
Issued: February 20, 2013			
This calibration certificate shall not be reproduced except in full without written approval of the laboratory.			

**References**

- [1] ANSI-C63.19-2007  
American National Standard for Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.
- [2] DASY manual, Chapter "Hearing Aid Compatibility (HAC) T-Coil Extension"

**Methods Applied and Interpretation of Parameters**

- **Coordinate System:** The TMFS is mounted underneath the HAC Test Arch touching equivalently to a wireless device according to [2] 29.2.2.: In "North" orientation, the TMFS signal connector is directed to the north, with x and y axes of TMFS and Test arch coinciding (see fig. 1). The rotational symmetry axis of the TMFS is aligned to the center of the HAC test Arch. For East, South and West configuration, the TMFS has been rotated clockwise in steps of 90°, so the connector looks into the specified direction. The evaluation of the radial direction is referenced to the device orientation (x equivalent to South direction).

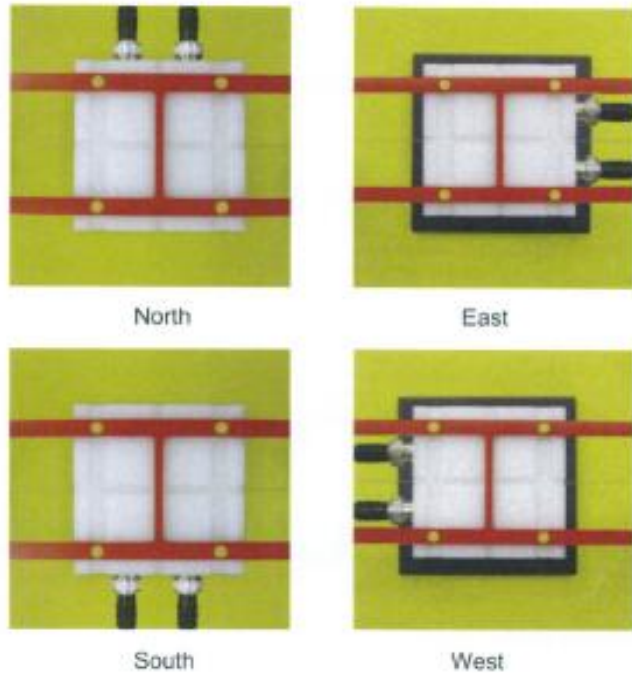


Fig. 1 TMFS scanning measurement configurations

- **Measurement Plane:** In coincidence with standard [1], the measurement plane (probe sensor center) is selected to be at a distance of 10 mm above the the surface of the TMFS touching the frame. The 50 x 50 mm scan area is aligned to the center of the unit. The scanning plane is verified to be parallel to the phantom frame before the measurements using the predefined "Geometry and signal check" procedure according to the predefined procedures described in [2].

- **Measurement Conditions:** Calibration of AM1D probe and AMMI are according to [2]. The 1 kHz sine signal for the level measurement is supplied from an external, independent generator via a BNC cable to TMFS IN and monitored at TMFS OUT with an independent RMS voltmeter or Audio Analyzer. The level is set to 0.5 Vrms and monitored during the scans.
- For the *frequency response*, a higher suppression of the background ambient magnetic field over the full frequency range was achieved by placing the TMFS in a magnetically shielded box. The AM1D probe was fixed without robot positioner near the axial maximum for this measurement. The background noise suppression was typ. 30 dB at 100 Hz (minimum) and 42 dB at 1 kHz. The predefined multisine signal (48k\_multisine\_50-10000\_10s.wav) was used and evaluated in the third-octave bands from 100 Hz to 10000 Hz.

### 1 Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V52.8.5 (1059)
DASY PP Version	SEMCAD	V14.6.8 (7028)
Phantom	HAC Test Arch	SD HAC P01 BA, #1002
Distance TMFS Top - Probe Centre	10 mm	
Scan resolution	dx, dy = 5 mm	area = 50 x 50 mm
Frequency	for field scans	1 kHz
Signal level to TMFS	for field scans	500 mV RMS
Signal	for frequency response	multisine signal 50-10000 Hz, each third-octave band

Table 1: System configuration

### 2 Axial Maximum Field

Configuration	East	South	West	North	Subset Average	Average
<b>Axial Max</b>	-20.13	-20.12	-20.14	-20.13		<b>-20.13</b>
TMFS Y Axis 1st Max	-25.54	-25.52	-25.54	-25.56		
TMFS Y Axis 2nd Max	-25.88	-25.88	-25.89	-25.85		
<b>Longitudinal Max Avg</b>	-25.71	-25.70	-25.72	-25.71	<b>-25.71</b>	
TMFS X Axis 1st Max	-25.86	-25.82	-25.87	-25.86		
TMFS X Axis 2nd Max	-25.58	-25.58	-25.56	-25.54		
<b>Transversal Max Avg</b>	-25.72	-25.70	-25.72	-25.70	<b>-25.71</b>	
<b>Radial Max</b>						<b>-25.71</b>

Table 2: Axial and radial field maxima measured with probe center at 10mm distance in dB A/m

The maximum was calculated as the average from the values measured in the 4 orientations listed in table 2.

**Axial Maximum -20.13 dB A/m** (+/- 0.33dB, k=2)

### 3 Radial Maximum Field

In addition, the average from the 16 maxima of the radial field listed in table 2 (measured at 10mm) was calculated:

**Radial Maximum -25.71 dB A/m**

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

4 Appendix

4.1 Frequency response

Max. deviation measured, relative to 1 kHz: min. -0.04, max. 0.01 dB

Frequency [Hz]	Response [dB]
100	-0.01
125	0.01
160	-0.01
200	0.00
250	-0.04
315	0.00
400	0.00
500	0.00
630	0.00
800	0.00
<b>1000</b>	<b>0.00</b>
1250	-0.01
1600	-0.01
2000	-0.01
2500	-0.01
3150	-0.01
4000	-0.02
5000	-0.02
6300	-0.03
8000	-0.03
10000	-0.03

Table 3: Frequency response

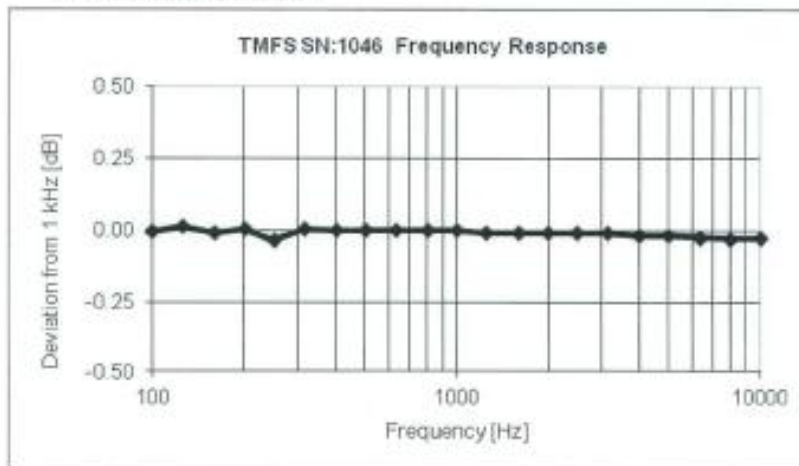


Fig. 2 Frequency response 100 to 10'000 Hz

4.2 Field plots

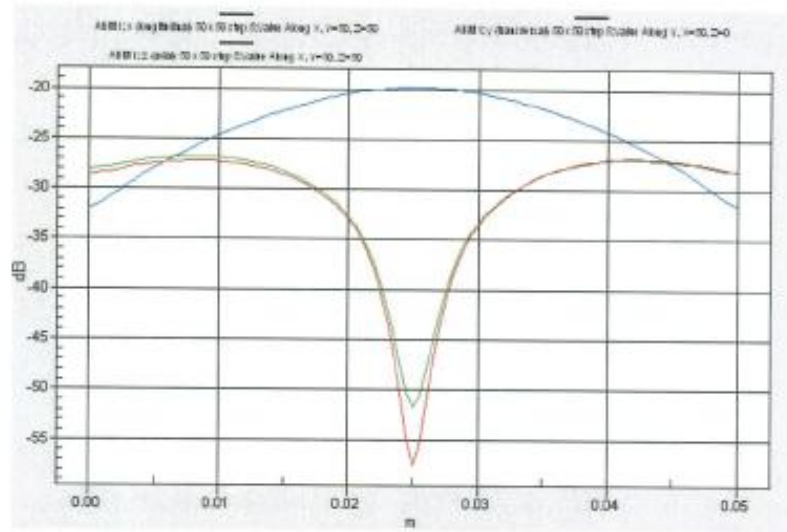


Fig. 3: Typical 2D field plots for x (red), y (green) and z (blue) components

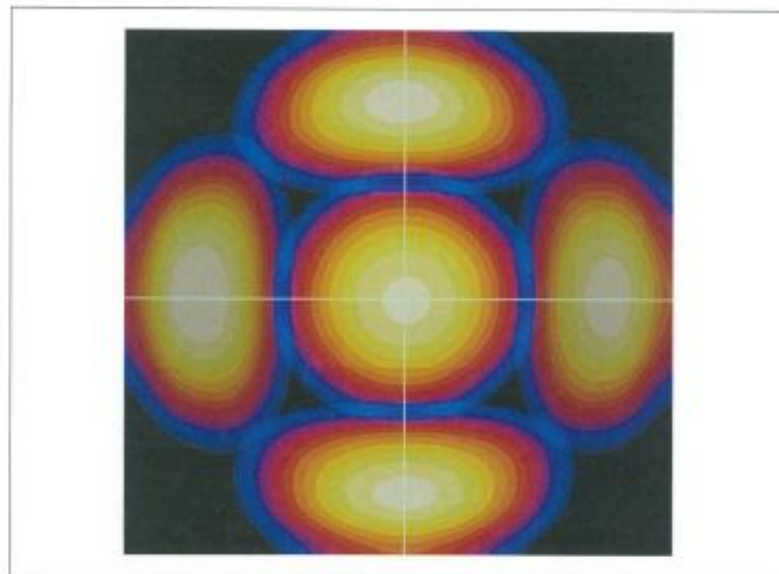


Fig. 4: Superposed field plots of z (axial), x and y radial magnetic field, 50 x 50 mm, individual scaling: white = max. field level, black = -4dB below max. The lines show the position of the 2D field plot of figure 3.

-----END OF REPORT-----